

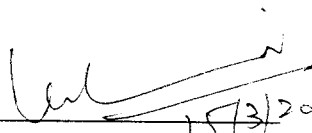
DEPARTMENT OF ELECTRICAL AND ELECTRONICS  
ENGINEERING  
KUMARAGURU COLLEGE OF TECHNOLOGY  
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CERTIFICATE

This is to certify that the project entitled  
“MOTOR MONITORING SYSTEM USING PIC  
MICROCONTROLLER”  
has been submitted by

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## SYNOPSIS

Monitoring the electrical parameters of a motor is essential in college laboratories and industries. For the measurement of electrical parameters, individual meters are used to measure current, voltage, speed, Temperature and frequency. Individual meters increase the cost and space required, also human error is unavoidable during observation. So we have developed an Instrument which measures all the electrical parameters using single instrument. A PIC microcontroller is used as processor which reads all the electrical parameters from the motor through Analog to Digital Converter and displays all the electrical parameters using seven segments LED Display sequentially. Since we have used embedded technology, the hardware is very compact in size and the cost involved is also very low.

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# CHAPTER-1

## INTRODUCTION

P.706

Most men are supposed to devote their time on creative work in order to improve the way and standard of living and comfort for the human society. But in reality many are employed only in doing the same work in a mechanical manner. Doing the same type of work repeatedly for days together cause strain and fatigue. Hence he has limitation in respect of speed and perfection while doing any repeated and routine jobs.

### 1.1. CONCEPTS OF MICROCONTROLLER

A microcontroller – one of the great inventions in digital electronics comes to rescue of the human being from the above drawbacks. Then the microcontrollers have begun to occupy a prime position in our daily life. Now a days microcontroller are used in computer, robotics, control of missile, satellite and industrial process control, biomedical field etc, to get accuracy, speed of work and easy to handle.

Motor monitoring is one of the essential requirements in college laboratories and industrial testing. For this individual meter are used for measurement of various parameters. Due to this size and cost is more and also human errors are introduced when readings are taken. The errors are avoided by constructing all the individual meters into single one using microcontroller.

## 1.2. GENERAL BLOCK DIAGRAM

The block diagram representation of Motor Monitoring system is shown in the Fig.1.1

For the measurement of voltage, the voltage input from the motor is stepped down by using suitable potential transformer. The reduced voltage is rectified and filtered and it is given as input to the multiplexer.

For the measurement of Current, the Current input from the motor is stepped down by using suitable potential transformer. The reduced current is rectified and filtered and it is given as input to the multiplexer.

For the measurement of temperature, the sensor which is connected to the motor body senses the temperature and it is converted into electrical signals which is amplified and given as input to the multiplexer.

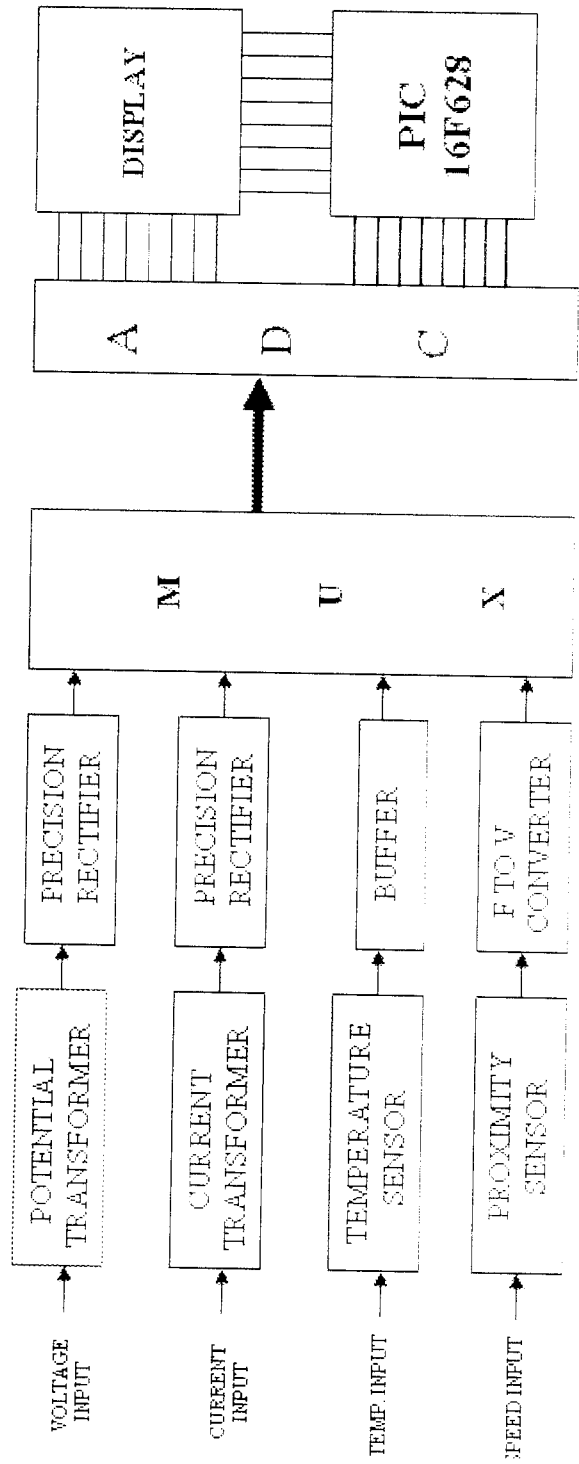
For the measurement of frequency, the voltage input signal is used. The voltage input signal which crosses the zero levels are measured with the help of PIC microcontroller.

For the measurement of speed, the proximity sensor converts the number of revolutions into pulses. The pulses are again converted into voltage by means of Frequency to Voltage converter and it is given as input to the multiplexer.

All the input parameters are given as input to the multiplexer which allows only one output at a time. The output of

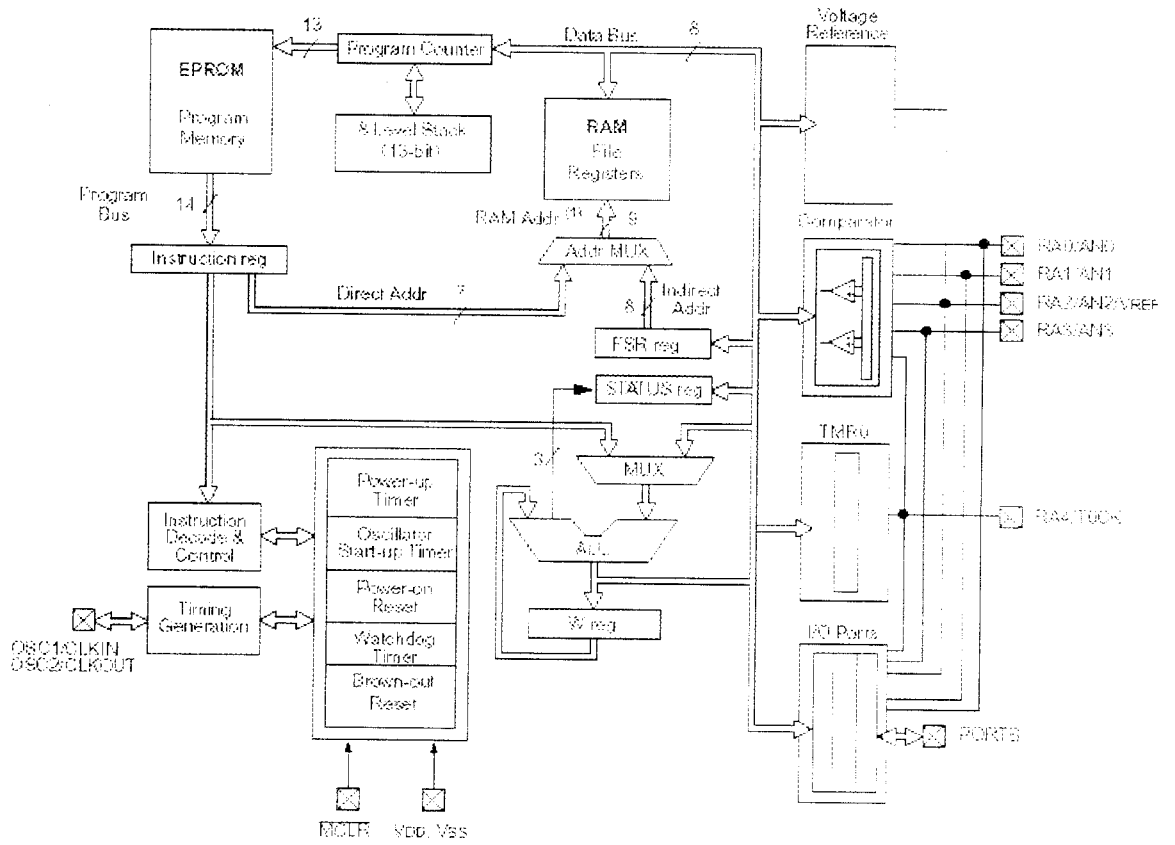
the multiplexer is given as input to the Analog to Digital converter which converts the analog input into digital output. The Digital output is given to PIC microcontroller for storage and all the input parameters are displayed by means of seven segment LED display.

### BLOCK DIAGRAM





## 2.1. ARCHITECTURE OF PIC 16C628



## **CHAPTER 2**

### **2.1.PIC 16C628 ARCHITECTURE**

PIC 16C628 is one of the most popular 8 bit microcontrollers. It is an 18 pin DIP fabricated on a single chip. Its clock speed is 10 MHz. It has 35 single word instructions. The architecture is shown in Fig.2.1. Various blocks are explained below.

#### **2.1.1. ARITHMETIC AND LOGIC UNIT:**

The arithmetic and logical unit perform various arithmetic and logical operations such as addition, subtractions, AND, OR, X-OR and rotate an 8 bit number. For ALU operation, one data must be in W register.

#### **2.1.2.W REGISTER:**

It is an 8 bit working register used for ALU operations. It is not an addressable register.

#### **2.1.3.STATUS REGISTER:**

The status register contains the arithmetic status of ALU, reset status and bank select bit for data memory. There are three flags used to know the status of ALU such as Digit carry flag, Carry flag and zero flag.

#### **2.1.4.PROGRAM COUNTER:**

The program counter (pc) is 13 bits wide. The low byte is PCL register which is readable and writable register. The high byte of the pc is neither directly readable nor writable and

comes from PCLATH register. It is a register used to store the address of the next instruction to be executed.

#### **2.1.5.STACK:**

The PIC 16C628 has an 8 deep x 13 bit wide hardware stack. The stack space is not part of either program or data space. The stack pointer is not readable or writable. The stack operates as circular buffer. (i.e.)After it has been pushed 8 times. the ninth push was stored from first push.

#### **2.1.6.MEMORY ORGANISATION:**

There are two memory blocks in PIC 16C628 microcontroller.

1. Program memory.
2. Data memory.

#### **2.1.7.PROGRAM MEMORY ORGANISATION:**

The PIC 16C628 has a 13 bit program counter capable of addressing 8kx14 program memory space. For PIC 16C628, the first 1kx14 are physically implemented. Accessing allocation above the physically implemented address will cause a wrap around. For example PIC 16C628 locations 20h, 420h. 820h will be the same instruction.

The reset vector is at 0000h and interrupt vector is at 0004h.

### **2.1.8.DATA MEMORY ORGANISATION:**

The data memory is partitioned into two areas. The first is the Special Function Register (SFR) area, while the second is the General Purpose Register (GPR) area. Data memory is partitioned into two banks which contain GPR & SFR. Bank 0 is selected by clearing the RP0 bit(STATUS). Bank 1 is selected by setting the RP0 bit(STATUS).

### **2.1.9.GENERAL PURPOSE REGISTER FILE:**

All devices have some amount of GPR area. Each GPR is 8 bits wide and is accessed either directly or indirectly through the FSR.

### **2.1.10SPECIAL FUNCTION REGISTERS:**

The Special function Registers are used by CPU and Peripheral function to control the device operation. These registers are static RAM.

### **2.1.11.I/O PORTS:**

The PIC 16C628 has two ports namely Port A & Port B .Some port pins are multiplexed with an alternate function for other features on the device.

### **2.1.12.PORT A AND TRIS A REGISTERS:**

Port A is a 5 bit wide latch.RA4 is a Schmitt Trigger input and open drain output. Setting a TRIS a bit will make the corresponding PORT A pin an input. Clearing a TRIS A bit will make the corresponding PORT A pin an output.

### **2.1.13.PORT B AND TRIS B REGISTERS:**

PORT B is an 8 bit wide bidirectional port .The corresponding data direction register is TRIS B.Clearing a TRIS B bit will make the corresponding PORT B pin an output. Setting a TRIS B bit will make the corresponding PORT B pin an output.

### **2.1.14.DATA EEPROM MEMORY:**

The EEPROM data memory is readable and writable during normal operation. These are four SFRS used to read and write this memory. These registers are

- EECON1
- EECON2
- EEDATA
- EEADDR

EEDATA holds the 8 bit data for read/write and EEADDR holds the address of the EEPROM location being accessed.PIC 16C628 devices have 64 bytes of data EEPROM with and address range form 0h to 3Fh.EECON1 is the control register with five low order bit implemented. Control bits RD and WR initiate read and write respectively.

## **2.2.FEATURES OF PIC 16C628 MICROCONTROLLER**

- Only 35 single word instructions
- All instructions are single cycle except for program branches which are two cycle.
- 14 bit wide instruction
- 8 bit wide data path.
- 15 special function hardware register
- Eight level deep hardware stack
- Direct, Indirect and Relative addressing Modes.
- 13 I/O pins with individual directional control

## **2.3.SPECIAL FEATURES OF PIC MICROCONTROLLER**

- In circuit serial programming
- Power on reset (POR)
- Power up timer (PWRT)
- Selectable Oscillator options
- Watchdog timer (WDT)
- Code protection
- Power saving SLEEP mode

## **CHAPTER 3**

### **HARDWARE**

#### **3.1. MEASUREMENT OF VOLTAGE**

In this section, voltage input from the motor is measured. The circuit diagram for voltage measurement is shown in Fig.3.1. It consists of 230/12v step down potential transformer, Bridge rectifier, capacitor filter, protection zener and variable potentiometer. The voltage from motor is given to 230/12v potential transformer where the voltage is reduced to 12v. The bridge rectifier is connected to the secondary of the potential transformer. During the positive half cycle, the diode D1 and D3 conducts and during the negative half cycle, the diode D2 and D4 conducts. So the output voltage is unidirectional. That is the AC voltage is converted into DC voltage. In order to avoid the ripple in the DC output, Capacitor filter is used. The filtered output voltage is available across variable potentiometer which is given as input to the multiplexer. Zener diode is used as a regulating element.

#### **3.2. MEASUREMENT OF CURRENT**

In this section, current input from the motor is measured. The circuit diagram for current measurement is shown in Fig.3.2. It consists of 3A/300mA step down current transformer, Bridge rectifier, capacitor filter, protection zener and variable potentiometer. The current from motor is given to 3A/300A current

transformer where the current is reduced to 300mA. The bridge rectifier is connected to the secondary of the current transformer. During the positive half cycle, the diode D1 and D3 conduct and during the negative half cycle, the diode D2 and D4 conduct. So the output current is unidirectional. That is the AC current is converted into DC current. In order to avoid the ripple in the DC output, Capacitor filter is used. The filtered output current is available across variable potentiometer which is given as input to the multiplexer. Zener diode is used as a regulating element.

### **3.3. MEASUREMENT OF SPEED**

In the section, the speed of the motor is measured. The circuit diagram for the speed measurement is shown in Fig.3.3. It consists of proximity sensor, Frequency to Voltage converter (2917) and Relay driving circuit. The proximity sensor converts the number of revolutions into pulses. The pulses are given as input to the Frequency to Voltage converter through pin 1. The Frequency to Voltage converter converts the pulses into voltage linearly. The output of the Frequency to Voltage converter is available at pin 3 and 4, which is given as input to the multiplexer.

The reference input for Frequency to Voltage converter is given through potentiometer p3 at pin 10. The internal comparator compares the reference input and measured input. If the measured input is above reference input, the pin 8 will give



signal to the transistor which operates the relay to indicate that the speed is increased rated speed.

### **3.4. MEASUREMENT OF TEMPERATURE**

In this section, the motor temperature is measured. The circuit diagram for temperature measurement is shown in Fig.3.4. It consists of an IC LM324, Temperature sensor and Relay driving circuit.

The IC LM324 consists of four op-amps such as A1, A2, A3, A4. The op-amp A1 is used for voltage stabilization.

The Temperature sensor (Diode) is connected between inverting input and output of the op-amp A2. If the temperature varies, the junction drop across the diode varies which results in change in input voltage to inverting terminal of op-amp A2. The output of op-amp A2 is given to inverting terminal op-amp A3 which acts as an amplifier. The output of the op-amp A3 is given as input to the analog multiplexer.

The op-amp A4 acts as a comparator. The op-amp A4 compares the measured temp and reference temperature. If the temperature is above reference valued, the op-amp give signal to the driver circuit which switch on the relay to indicate that the temperature is exceeding the limit, by means of LED.

### **3.5. MEASUREMENT OF FREQUENCY**

For the measurement of frequency, the voltage input signal is used. The voltage input signal which crosses the zero levels are measured with the help of PIC microcontroller. By means of programming, it can be displayed using Seven Segment LED Display.

### **3.6. PROCESSOR SECTION:**

The circuit diagram of processor section is shown in Fig3.6.. It consists of multiplexer, Analog to Digital Converter, Tristate buffer and PIC 16C628 microcontroller. All the input parameters are given as input to the multiplexer .The PIC 16C628 microcontroller send the address to the multiplexer which allows only one parameters at a time to Analog to Digital converter.

After the SOC signal is given to the Analog to Digital converter, it converts the analog signal into Digital signal. After the conversion process, the Analog to Digital converter send EOC signal to microcontroller and the digital data available on the data bus is stored in the memory of the microcontroller.

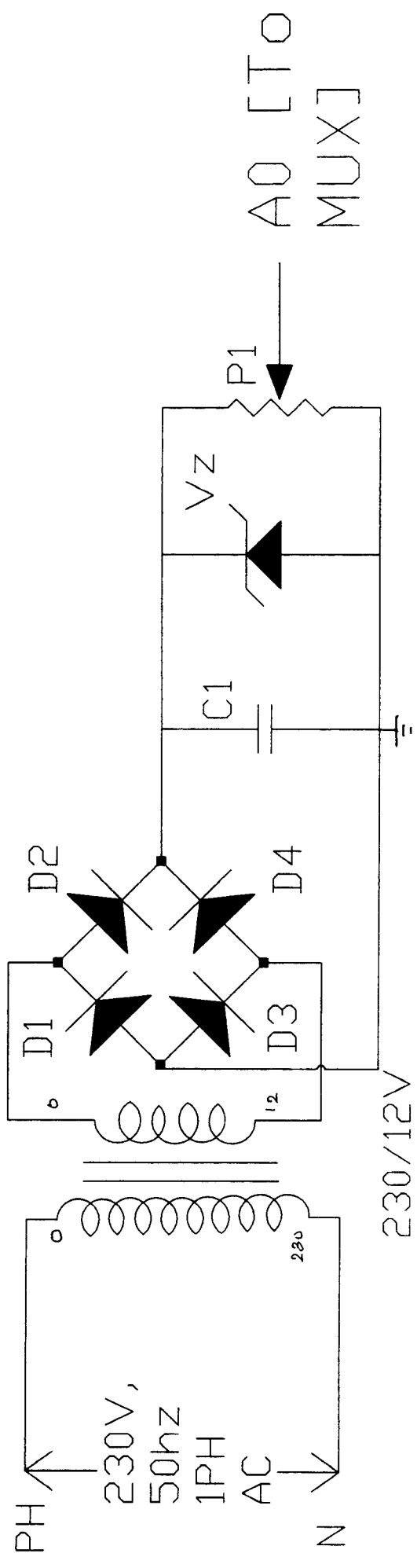
Then the microcontroller sends next address to the multiplexer and the same process continues until all the input parameters are scanned.

There are two tristate buffers used in this section to access the port B pin as input port as well as output port. When Tristate buffer 1 is enabled, port B acts as an input port and when Tristate buffer 2 is enabled, port B acts as an output port.

### **3.7. DISPLAY SECTION**

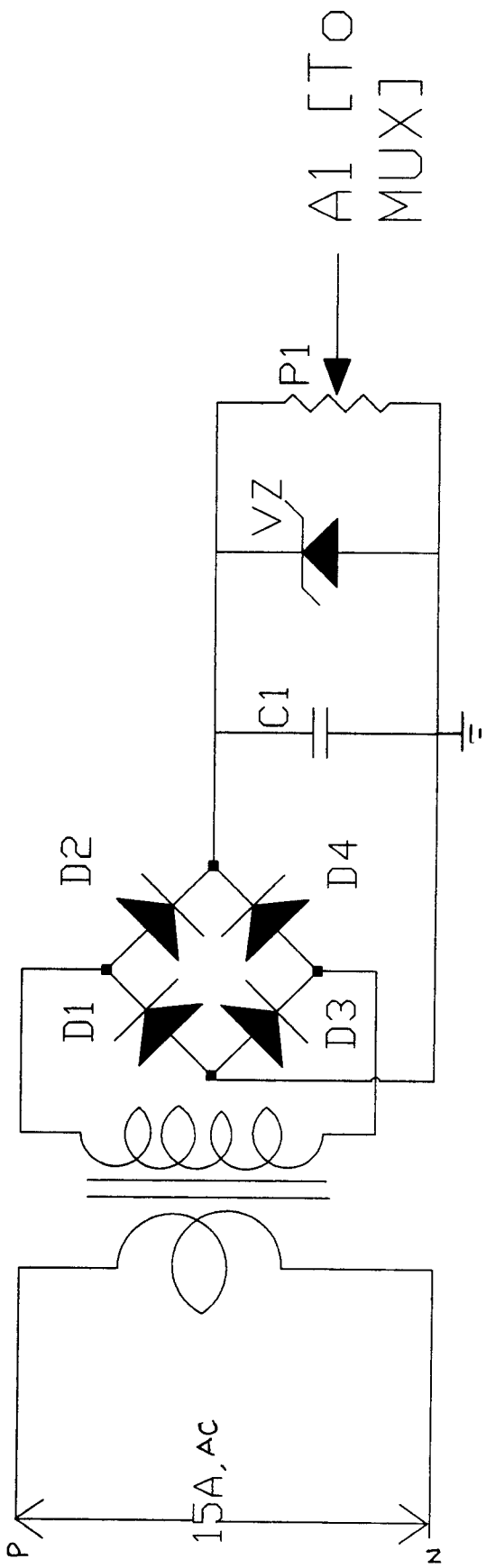
The circuit diagram of Display section is shown in the Fig.3.6. It consists of four decoders (IC 4094) and four seven segment LED displays. Each decoder consists of three important pins called as Data, Strobe, and clock. The Strobe and clock signal is given to all the decoders. The binary data from the microcontroller is given to the data pin of the decoder. After the clock pulse is given, the first data is displayed on the seven segment display and it is shifted to second display and so on. Thus an input parameter is displayed on seven segment LED display.

# CIRCUIT FOR MEASURING VOLTAGE



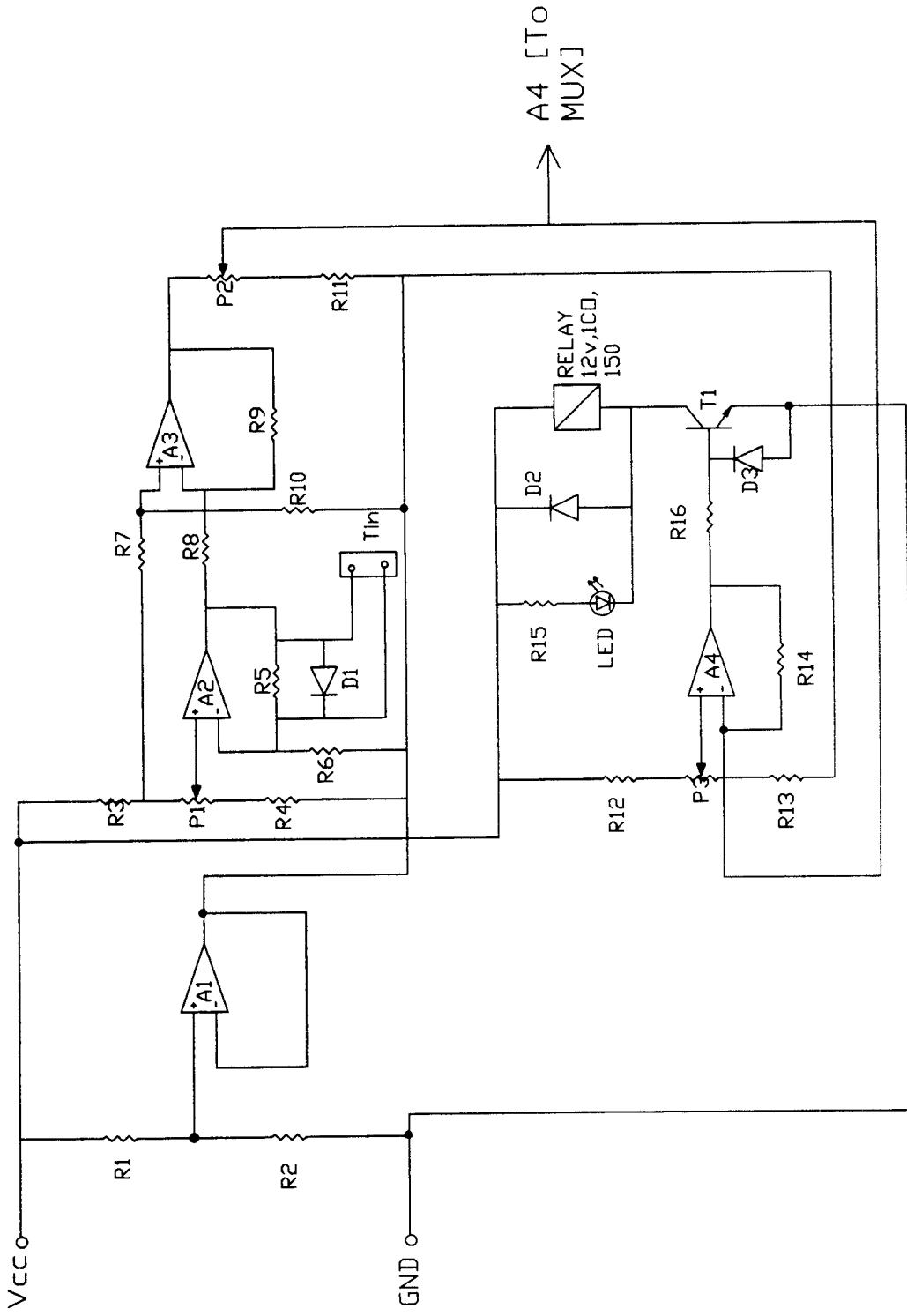
- D1 = D2 = D3 = D4 = 1N4001
- C1 = 0.01MF
- VZ = 5.2v
- P1 = 10K

# CIRCUIT FOR MEASURING CURRENT



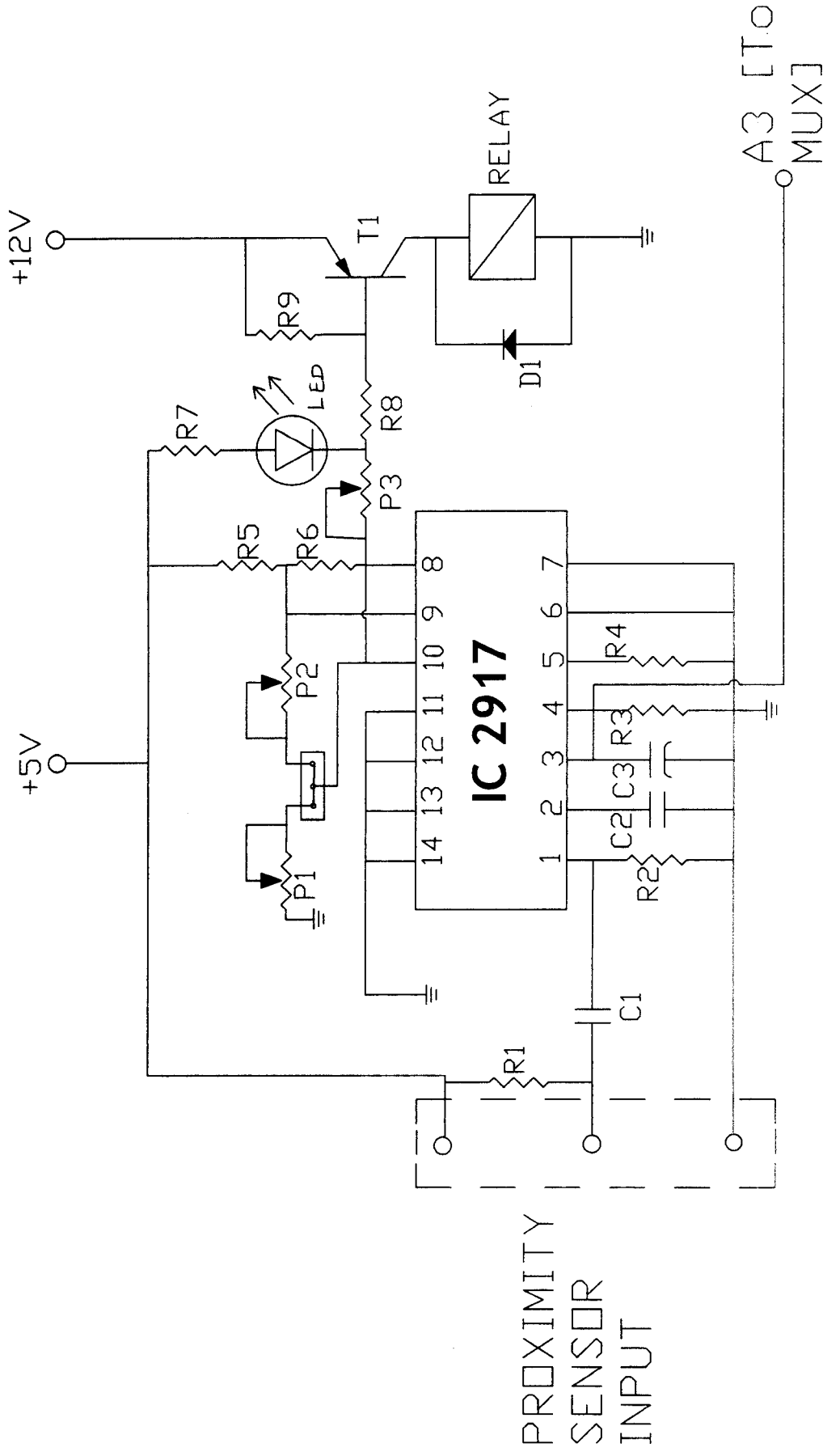
D1 = D2 = D3 = D4 = 1N4001      VZ = 5.2V  
C1 = 0.01MF                      P1 = 10K

# CIRCUIT FOR MEASURING TEMPERATURE



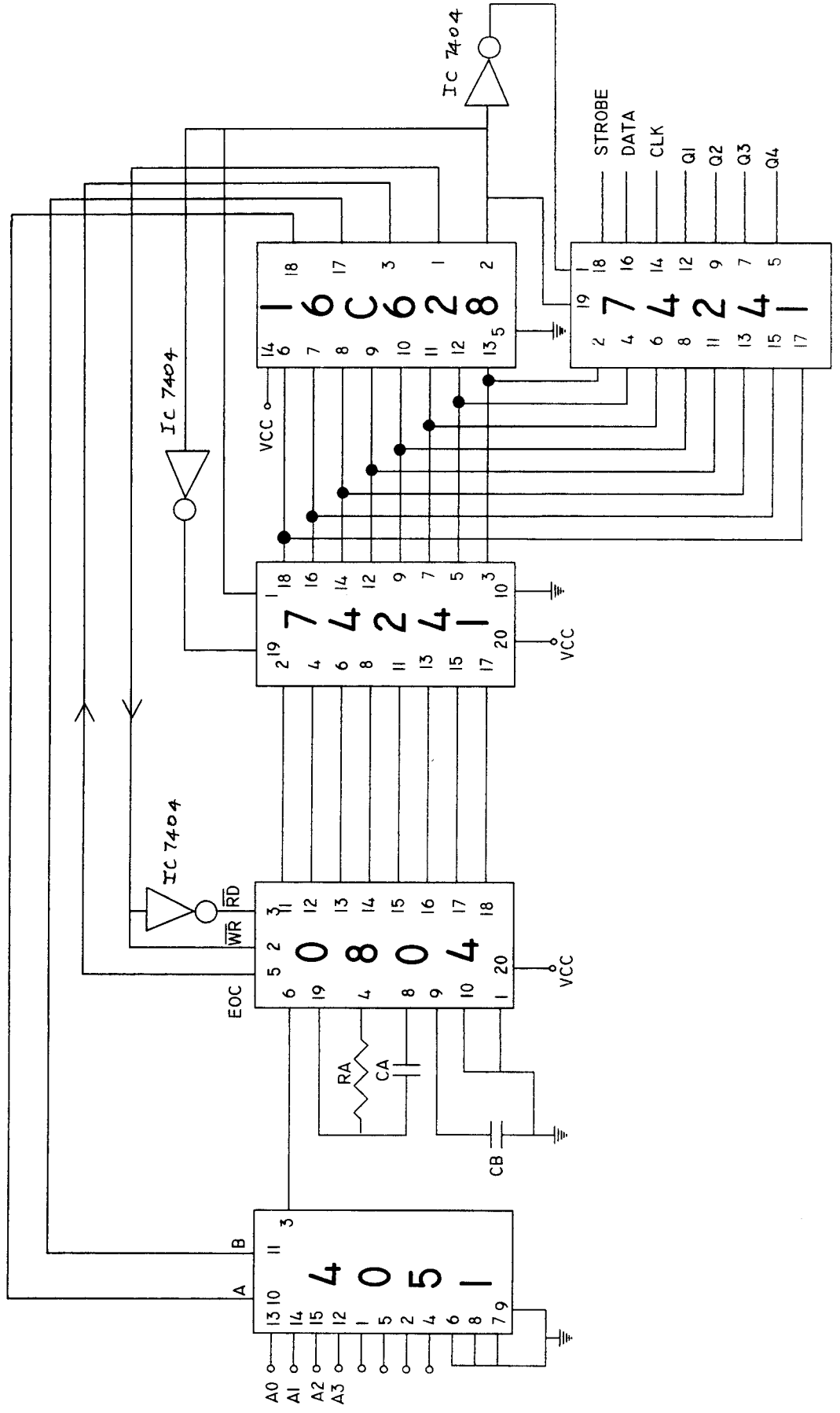
- A1=A2=A3=A4=IC LM324
- R1=R2=R8=R11=10K
- R3=680 Ω
- R4=R12=2.2K
- R5=R6=R7=R13=R15=1K
- R9=R10=R16=6.8K
- D1=1N4148
- D2=D3=1N4001
- T1=BC547
- V<sub>cc</sub> = 12V

# CIRCUIT FOR MEASURING SPEED



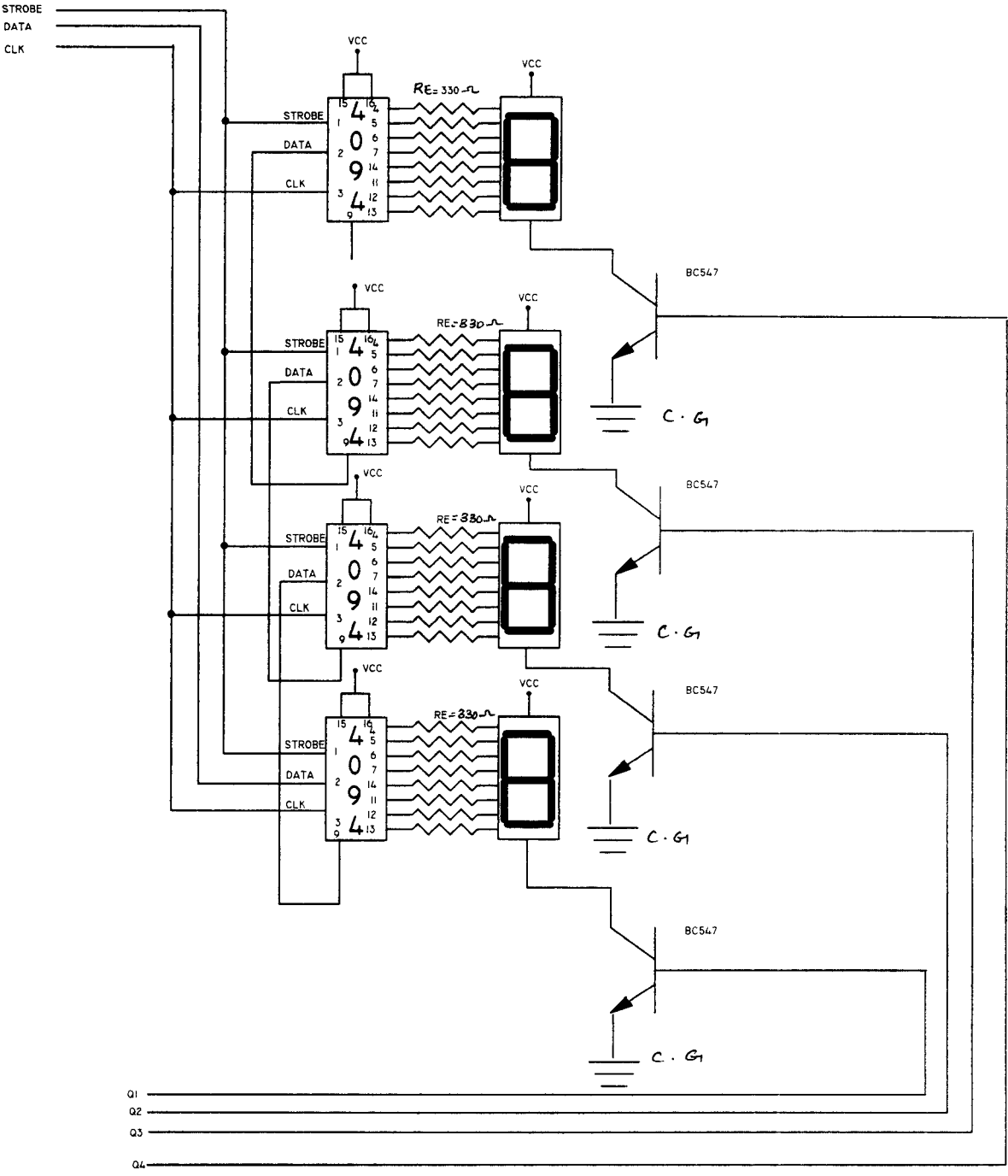
- R1=R2 = 10k
- R3=R4=100k
- R3=R4=100k
- R5=680  $\Omega$
- R6=R7=R8=R9=1k
- P1=P2=P3=10k
- C1=C2=0.01MF
- T1=BC547
- D1=1N4001

# PROCESSOR SELECTION





# DISPLAY SECTION



### **3.8.DESCRPTION OF HARDWARE DESIGN**

The circuit diagram of the motor monitoring system is shown in the figure. It consists of various sections such as voltage measurement and frequency measurement sections. In the voltage measurement section, the voltage input from the motor is applied to 230/12v step-down potential transformer, where the voltage is reduced to 12v .The Bridge rectifier converts the Ac voltage into Dc voltage.(i.e)During the positive half cycle, the output voltage is positive for full half cycle. During the negative half cycle ,the diodes D2 and D3 are forward biased and the output voltage is also positive for remaining half cycle. The rectified output contains Ac components and the Dc parts. The Ac components called ripples should be removed to get a smooth output.Therefore it is necessary to include filter between rectifier and the output to avoid the ripples. The filtered output voltage which is available across potentiometer is given to A0 of the multiplexer.

In the current measurement section, the current input from the motor is applied to 3A/300mA current transformer, where the current is reduced to 300mA.The Bridge rectifier converts the Ac current into Dc current.(i.e.) During the positive half cycle, Diode D1 and D4 are forward biased and the output current is positive for full half cycle. During the negative half cycle, Diode D2 and D3 are forward biased and the output current

is positive for full half cycle. The rectified output contains Ac components as well as Dc components. The Ac components called ripples are removed to get the smooth output. Therefore it is necessary to include the filter between rectifier and output to avoid the ripples. The filtered output voltage which is available across potentiometer is given to A1 of the multiplexer.

In the speed measurement section, the proximity sensor converts the motor revolution into pulses which is applied to the pin 1 of the frequency to voltage converter. The Frequency to voltage converter converts the pulses into voltage linearly. The output voltage which is available across pin 3 and 4 is given to the A3 of the multiplexer. The reference input is given to pin 10 of the Frequency to voltage converter through potentiometer p1 and p2. The internal comparator in the Frequency to voltage converter compares the reference input and measured input. If the measured input exceeds reference input the signal is given to transistor T1 to operate the relay and LED to indicate that the speed is above normal.

In the temperature measurement section, the IC LM324 consists of four op-amps such as A1, A2, A3 and A4. The op-amp A1 acts as a voltage follower and it is used for voltage stabilization. The Temperature sensor is connected across inverting terminal of op-amp A2. The reference input is given to non-inverting terminal of A2 through potentiometer p1. If the temperature varies, the junction drop across diode varies which

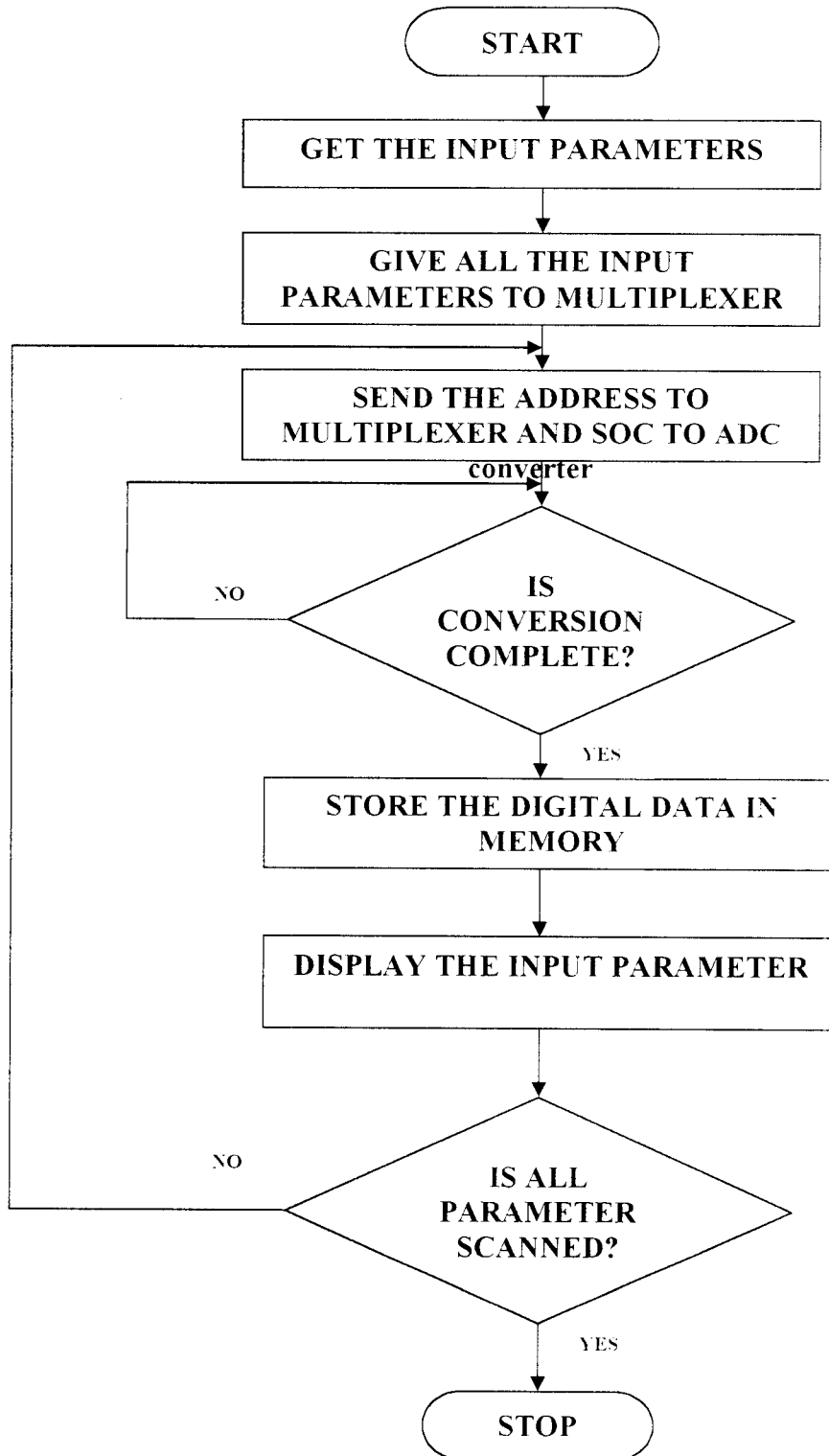
causes the change in output voltage of op-amp A2. The output of op-amp A2 is given to inverting terminal of op-amp A3 which is available across p2 is given to A4 of multiplexer. The op-amp A4 compares the measured input and reference input if the measured input is above reference input, the output of op-amp A4 will give signal to transistor to switch on the relay and LED to indicate that the temperature is exceeding the limit.

In the frequency measurement section, the voltage input signal which crosses the zero levels are measured and displayed by means of programming in PIC microcontroller.

All the input parameters are applied to multiplexer 4051 which allows only one output depends upon the status signals given to the multiplexer. First the microcontroller sends status signals to the multiplexer and SOC to the Analog to Digital Converter. Then the multiplexer sends the voltage input to the Analog to Digital Converter and then Analog to Digital Converter starts converting the analog signal into Digital signal. After converting the analog signal into Digital signal the Analog to Digital Converter send EOC signal to microcontroller to indicate that the conversion is over. The Digital Data which is available in the port B pins is stored in the memory of the microcontroller. There are two tristate buffers used to use port B pins as input port as well as output port. If the tristate Buffer 1 is enabled, Port b is used as input port and vice versa. Then the microcontroller sends next status signals and the process continues until all the

parameters are scanned. The data which is available in the microcontroller is sending to data pin of the last IC 74241 decoder and data is transferred to next decoder and so on. The clock and strobe signals are given to all the decoders from the microcontroller. Thus the digital data is displayed using seven segments LED.

#### 4.1. FLOWCHART:



```
;-----  
W      EQU   00  
F      EQU   01
```

```
;----- Register Files-----
```

```
INDF      EQU   00      ;register file definition  
TMR0      EQU   01  
PCL       EQU   02  
STATUS    EQU   03  
FSR       EQU   04  
PORTA     EQU   05  
PORTB     EQU   06  
OPTION_REG EQU   81  
TRISA     EQU   85  
TRISB     EQU   86  
RB0       EQU   00      ;port 'B' definition  
RB1       EQU   01  
RB2       EQU   02  
RB3       EQU   03  
RB4       EQU   04  
RB5       EQU   05  
RB6       EQU   06  
RB7       EQU   07
```

```
;----- STATUS Bits-----
```

```
Z      EQU   02  
C      EQU   00  
RA4    EQU   04  
RA0    EQU   00
```

RA1	EQU	01
RA2	EQU	02
RA3	EQU	03
RA4	EQU	04
RB7	EQU	07
F	EQU	01

;------

SCRTCH0	EQU	20
SCRTCH1	EQU	21
LSD	EQU	22
MSD	EQU	23
MMSD	EQU	24
VOLTAGE	EQU	25
TMR_COMP	EQU	26
COUNTER_100MS_1	EQU	27
COUNTER_4MS_1	EQU	28
TMR_COMP_1	EQU	29
UNIT	EQU	2A
TENS	EQU	2B
HUND	EQU	2C
CURRENT	EQU	2D
DSP	EQU	2E
SPEED	EQU	2F
AARGB0	EQU	30
BARGB0	EQU	31
AARGB1	EQU	32
LOOPCOUNT	EQU	33
DISP_STROBE	EQU	0
DISP_DATA	EQU	2



```

DISP_CLK          EQU 1
RA3               EQU 3
RA7              EQU 7
;-----
#DEFINE DATA_HI BSF PORTB, DISP_DATA
#DEFINE DATA_LO BCF PORTB, DISP_DATA
#DEFINE CLK_HI   BSF  PORTB, DISP_CLK
#DEFINE CLK_LO  BCF  PORTB, DISP_CLK
#DEFINE STROBE_HI BSF PORTB, DISP_STROBE
#DEFINE STROBE_LO BCF PORTB, DISP_STROBE
;-----

```

```

                DIS      NOP                                ;display 7 segment data
                                                         serially
MAIN0           RLF SCRTCH1,F
                BTFSC STATUS,C
                GOTO MAIN1
                DATA_LO
                GOTO MAIN2
MAIN1           DATA_HI
MAIN2           NOP
                NOP
                CLK_HI
                NOP
                NOP
                CLK_LO
                NOP
                NOP
                DECFSZ SCRTCH0,F
                GOTO MAIN0

```

STROBE\_HI

NOP

STROBE\_LO

DATA\_LO

RETURN

;------

LUT ADDWF PCL,F ; 7 segment lookup table

RETLW B'00000011' ;0

RETLW B'10011111' ;1

RETLW B'00100101' ;2

RETLW B'00001101' ;3

RETLW B'10011001' ;4

RETLW B'01001001' ;5

RETLW B'01000001' ;6

RETLW B'00011111' ;7

RETLW B'00000001' ;8

RETLW B'00011001' ;9

;------

DELAY MOVLW 0XFA ;4000 MICRO SEC (1:16 \* 250)

MOVWF TMR\_COMP\_1 ;800 msec delay routine

REPS MOVF TMR\_COMP\_1,W

XORWF TMR0,W

BTFSS STATUS,Z

GOTO REPS

MOVLW 0XFA

ADDWF TMR\_COMP\_1,F

INCF COUNTER\_4MS\_1,F

MOVLW 0X19

```

XORWF COUNTER_4MS_1,W;IS4MS*25=100MSEC
OVER
BTFSS STATUS,Z
OTO REPS
CLRF COUNTER_4MS_1
INCF COUNTER_100MS_1,F
MOVLW 0X0A      ;100 MSEC DELAY
XORWF COUNTER_100MS_1,W
BTFSS STATUS,Z
GOTO REPS
CLRF COUNTER_100MS_1
RETURN

```

```

-----
BINBCD      CLRF MSD;8 bit binary to BCD routine conversion
            MOVWF LSD
            TENTH    MOVLW .10
            SUBWF LSD,W
            BTFSS STATUS,C
            GOTO OVER
            MOVWF LSD
            INCF MSD,F
            GOTO TENTH
OVER        RETLW 0

```

```

-----
MUL        MOVLW 0X08      ;speed data * 4 multiplication routine
MOVWF LOOPCOUNT
            MOVF AARGB0,W
LOOP       RRF BARGB0, F
            BTFSC STATUS,C

```

```

                                GOTO LUM
                                DECFSZ LOOPCOUNT, F
                                GOTO LOOP
                                CLRF AARGB0
                                RETLW 0X00
LUM                                BCF STATUS,C
                                GOTO LUM08
LOOPUM                            RRF BARGB0, F
                                BTFSC STATUS,C
                                ADDWF AARGB0, F
LUM08                            RRF AARGB0, F
                                RRF AARGB1, F
                                DECFSZ LOOPCOUNT, F
                                GOTO LOOPUM
                                RETURN
;-----
START                            CLRF PORTA
                                CLRF PORTB                :clear all files
                                CLRF INTCON
                                CLRF COUNTER_100MS_1
                                CLRF COUNTER_4MS_1
                                CLRF TMR_COMP_1
                                CLRF LSD
                                CLRF MSD
                                CLRF MMSD
                                CLRF UNIT
                                CLRF TENS
                                CLRF HUND
                                CLRF AARGB0

```

```

CLRF BARGB0
CLRF AARGBI
CLRF LOOPCOUNT
MOVLW 0X07
MOVWF CMCON
BSF STATUS,5
MOVLW B'10010000'
MOVWF TRISA
MOVLW B'11111111'
MOVWF TRISB
CLRF TMR0
MOVLW 0XC3 ;TIMER0 PRESCALE 1:16
OPTION
BCF STATUS,5

```

```

CYCLE   BSF STATUS,5
        MOVLW B'11111111'
        MOVWF TRISB
        BCF STATUS,5
        BCF PORTA,RA3      ;READ MODE
        BCF PORTA,RA0      ;ANALOG MUX SEIECTION
        BCF PORTA,RA1
        BCF PORTA,RA2      ;SOC
        CALL DELAY
        BSF PORTA,RA2
CHECK   BTFS PORTA,RA4      ;CHECK FOR EOC
        GOTO CHECK
        MOVF PORTB,W
        MOVWF VOLTAGE

```

```

BSF PORTA,RA3      ;DISPLAY MODE
BSF STATUS,5
MOVLW B'00000000'
MOVWF TRISB
BCF STATUS,5

MOVLW 0XC7
MOVWF DSP

```

```

DISPLAY          BSF PORTB,RB7 ;display voltage data
                 MOVLW H'08'
                 MOVWF SCRTCH0
                 MOVF DSP,W
                 MOVWF SCRTCH1
                 CALL DIS
                 MOVLW H'08'
                 MOVWF SCRTCH0
                 MOVF HUND,W
                 MOVWF SCRTCH1
                 CALL DIS
                 MOVLW H'08'
                 MOVWF SCRTCH0
                 MOVF TENS,W
                 MOVWF SCRTCH1
                 CALL DIS
                 MOVLW H'08'
                 MOVWF SCRTCH0
                 MOVF UNIT,W

```

```

MOVWF SCRTCH1
CALL DIS
CLRF LSD
CLRF MSD
CLRF MMSD
CLRF UNIT
CLRF TENS
CLRF HUND
CLRF VOLTAGE
CALL DELAY
BCF PORTB, RB4
BCF PORTB, RB5
BCF PORTB, RB6
BCF PORTB, RB3

BSF STATUS, 5
MOVLW B'11111111'
MOVWF TRISB
BCF STATUS, 5
BCF PORTA, RA3      ;READ MODE
BCF PORTA, RA0
BSF PORTA, RA1      ;ANALOG MUX SELECT
BCF PORTA, RA2      ;SOC
CALL DELAY
BSF PORTA, RA2
CHEC BTFSS PORTA, RA4      ;CHECK FOR EOC
GOTO CHEC
MOVF PORTB, W
MOVWF CURRENT

```

```

BSF PORTA,RA3      ;DISPLAY MODE
BSF STATUS,5
MOVLW B'00000000'
MOVWF TRISB
BCF STATUS,5

MOVLW 0X63
MOVWF DSP

BSF STATUS,5
MOVLW B'11111111'
MOVWF TRISB
BCF STATUS,5
BCF PORTA,RA3     ;READ MODE
BSF PORTA,RA0
BCF PORTA,RA1     ;ANALOG MUX SELECT
BCF PORTA,RA2     ;SOC
CALL DELAY
BSF PORTA,RA2
CHE               ;CHECK FOR EOC
BTFSS PORTA,RA4
GOTO CHE
MOVF PORTB,W
MOVWF AARGB0
MOVLW 0X04
MOVWF BARGB0
CALL MUL
MOVF AARGB0,W
MOVWF SPEED
BSF PORTA,RA3     ;DISPLAY MODE

```



```

BSF STATUS,5
MOVLW B'00000000'
MOVWF TRISB
BCF STATUS,5
BSF PORTB,RB3
MOVLW 0X11
MOVWF DSP

```

```

DISPL      BSF PORTB,RB7      :display "current"
           MOVLW H'08'
           MOVWF SCRTCH0
           MOVF DSP,W
           MOVWF SCRTCH1
           CALL DIS
           MOVLW H'08'
           MOVWF SCRTCH0
           MOVF HUND,W
           MOVWF SCRTCH1
           CALL DIS
           MOVLW H'08'
           MOVWF SCRTCH0
           MOVF TENS,W
           MOVWF SCRTCH1
           CALL DIS
           MOVLW H'08'
           MOVWF SCRTCH0
           MOVF UNIT,W
           MOVWF SCRTCH1

```

```
CALL DIS
CLRF LSD
CLRF MSD
CLRF MMSD
CLRF UNIT
CLRF TENS
CLRF HUND
CLRF SPEED
CALL DELAY
CLRF AARGB0
CLRF BARGB0
CLRF AARGB1
BCF PORTB,RB4
BCF PORTB,RB5
BCF PORTB,RB6
BCF PORTB,RB3
BCF PORTA,RA1
GOTO CYCLE
END
```

## **CHAPTER 5**

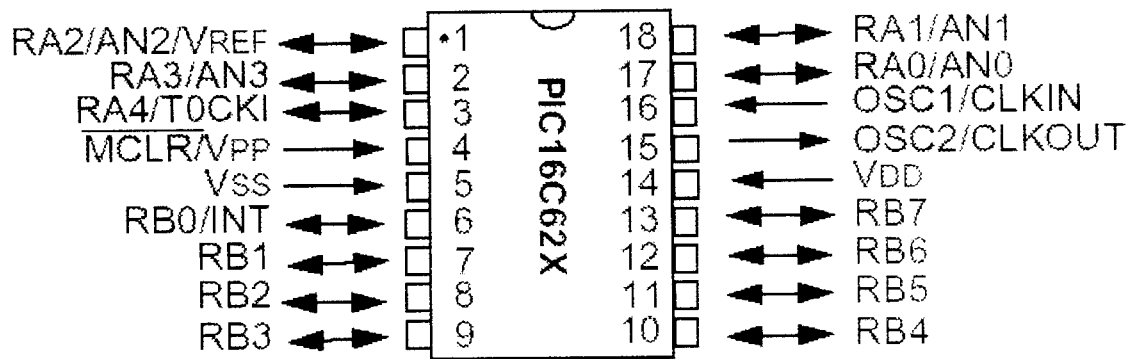
### **CONCLUSION**

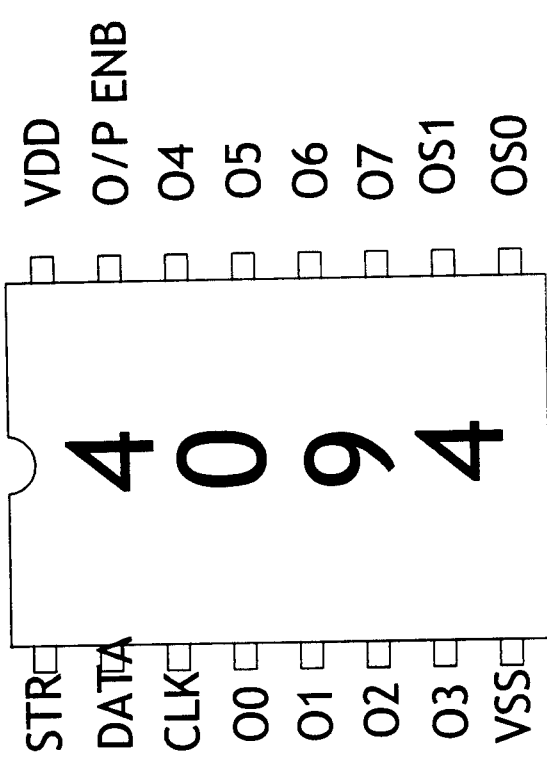
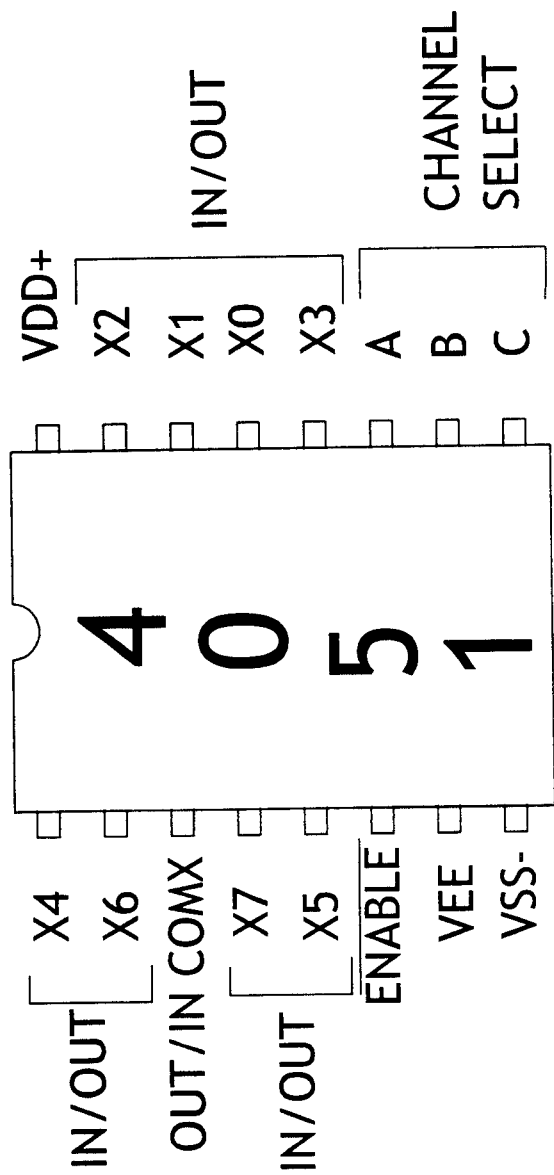
Monitoring the electrical parameters of motor has been implemented using PIC microcontroller. This project gives Current, voltage, temperature, frequency, speed without any error. In this project work, we have an exclusive study on the embedded systems. This project finds applications on college laboratories and industrial testings. by the implementation of this project, the motor monitoring is very simplex compared to conventional method of measuring electrical parameters. Since the size and cost of this system is reduced, there is future scope for this project in industries of very large power rating motors.

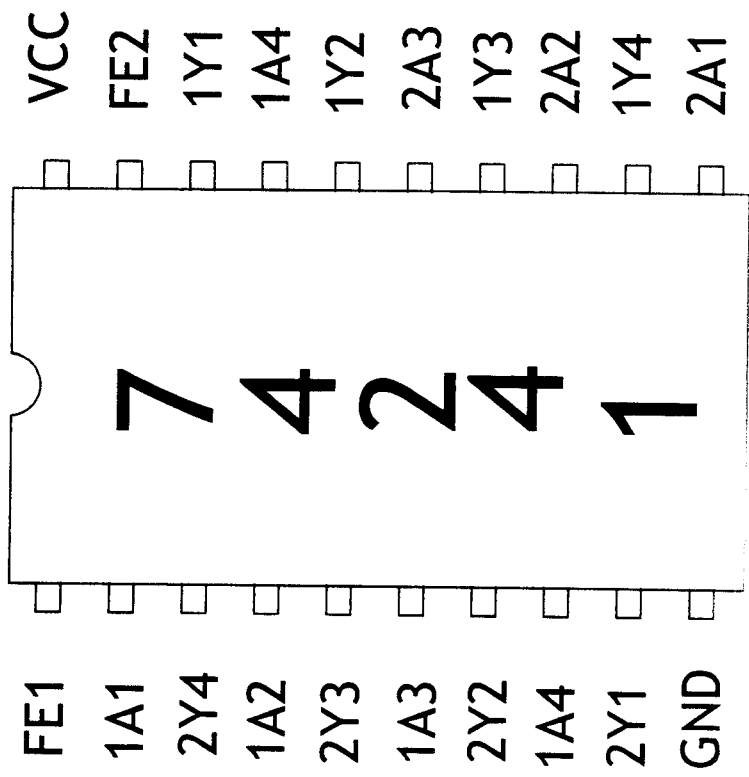
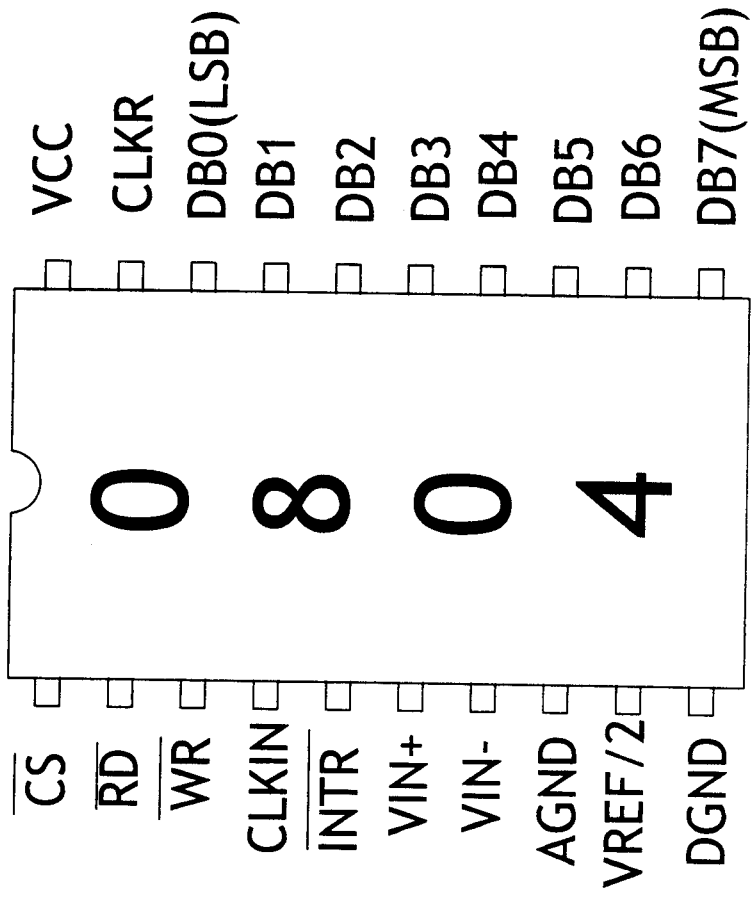
## BIBLIOGRAPHY

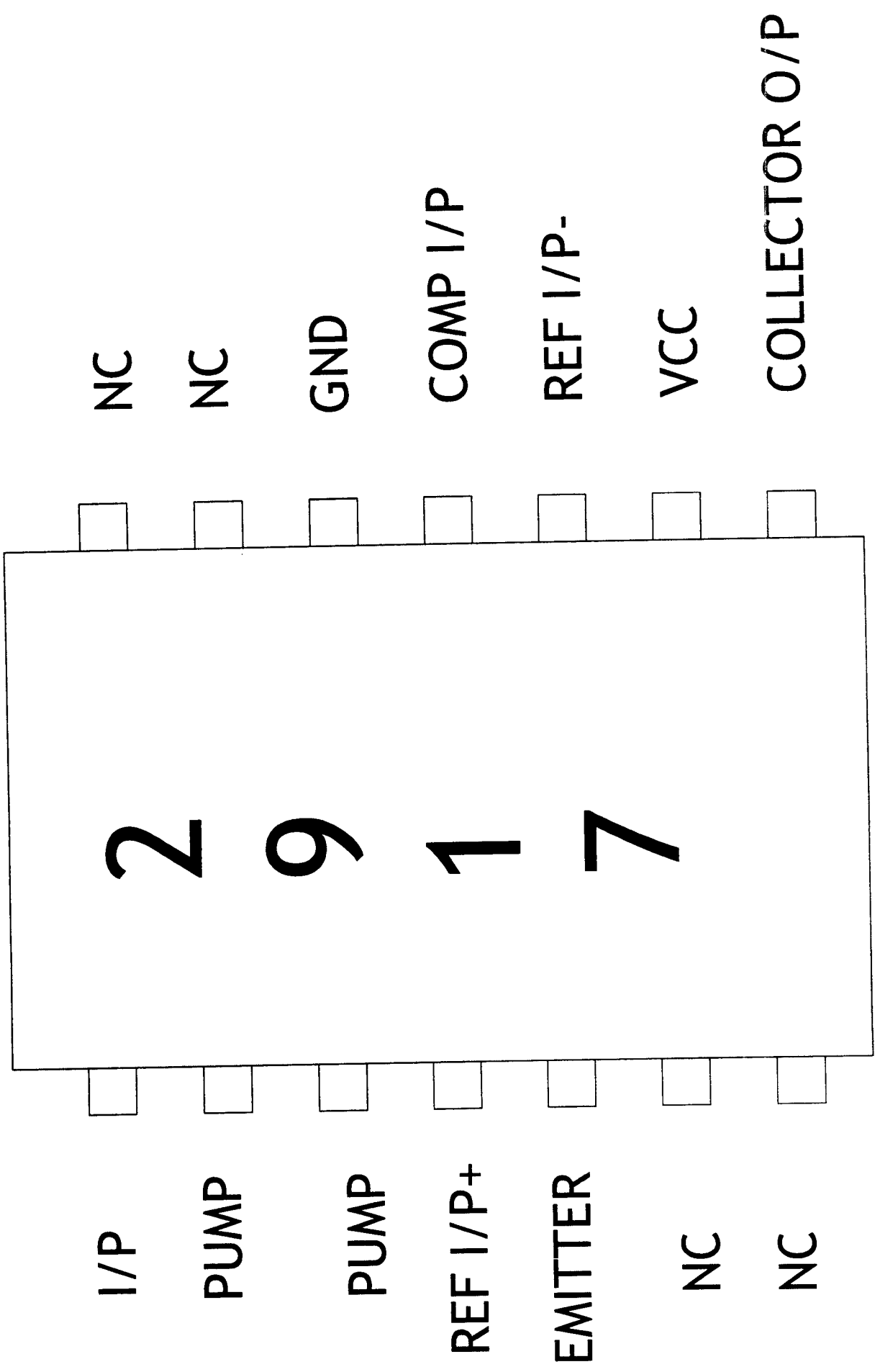
1. Gayakwad.A.R, "Op-amps and Linear ICs",– Prentice Hall of India,1993.
2. Floyd," Digital Fundamentals", 3rd Edition, Universal Book Stall, New Delhi,1995.
3. Franco," Design with Operational amplifier and analog integrated circuits" Tata McGraw Hill,1998.
4. "Microchip user manual"
- 5."Intersil user manual".
6. "National Instruments user manual"
7. [www.Keil.Com](http://www.Keil.Com)

## PIN CONFIGURATION OF PIC 16C628:

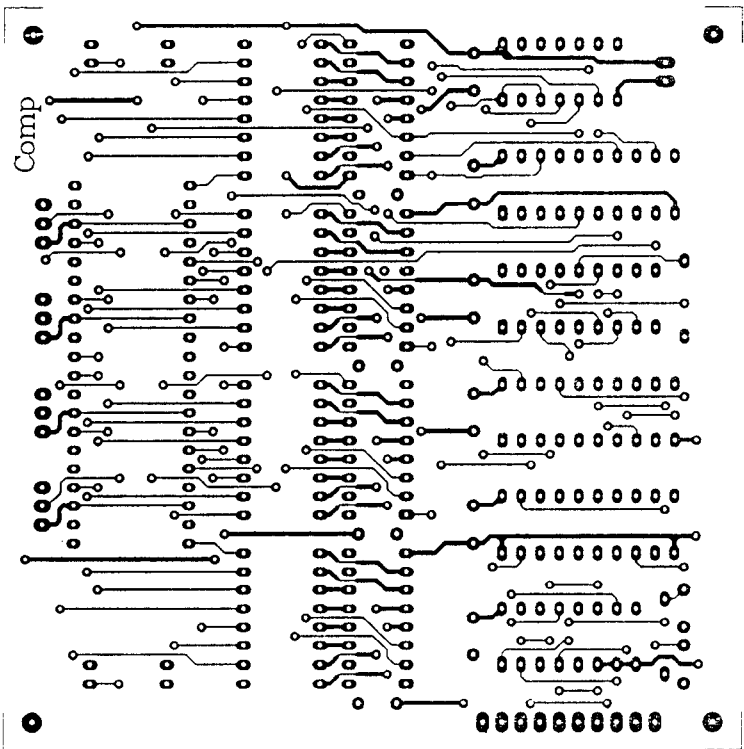
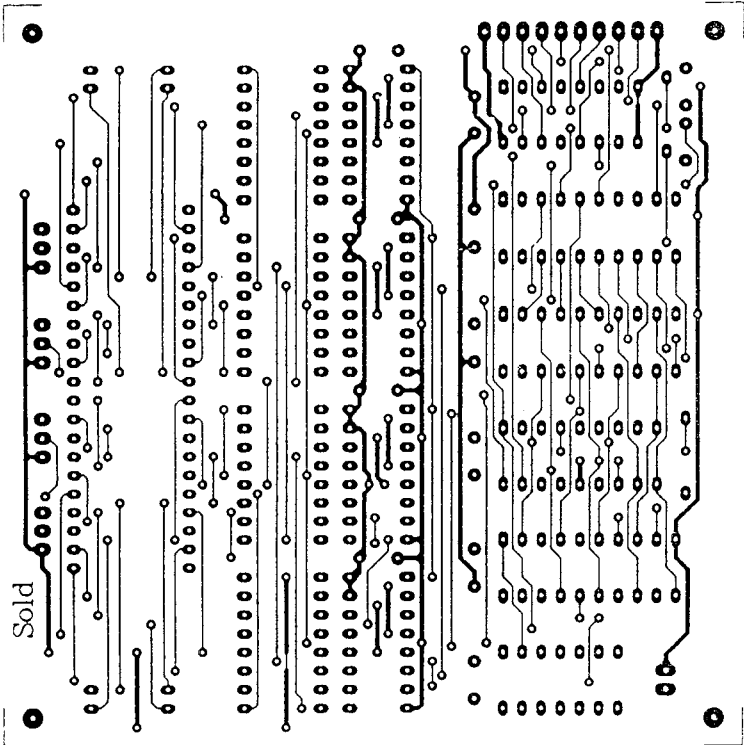


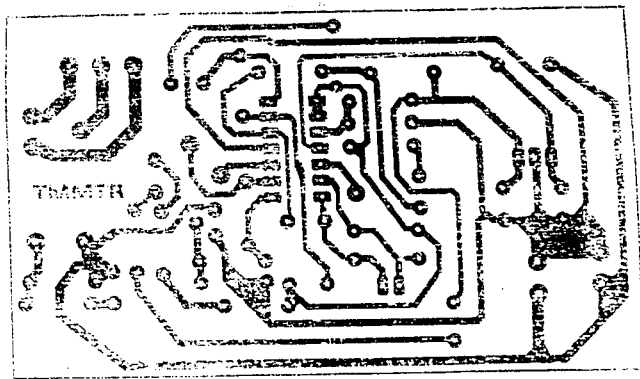
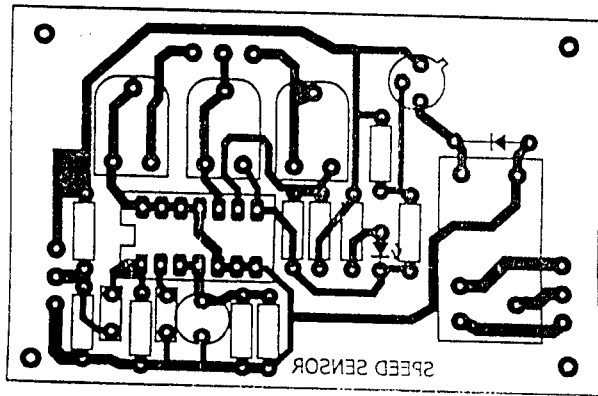












# LM124, LM224, LM324, LM2902

## Specifications and Applications Information

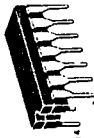
### QUAD LOW POWER OPERATIONAL AMPLIFIERS

The LM124 Series are low-cost, quad operational amplifiers with true differential inputs. These have several distinct advantages over standard operational amplifier types in single supply applications. The quad amplifier can operate at supply voltages as low as 3.0 Volts or as high as 32 Volts, with quiescent currents about one fifth of those associated with the MC1741 (on a per amplifier basis). The common mode input range includes the negative supply, thereby eliminating the necessity for external biasing components in many applications. The output voltage range also includes the negative power supply voltage.

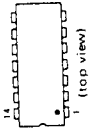
- Short Circuit Protected Outputs
- True Differential Input Stage
- Single Supply Operation: 3.0 to 32 Volts
- Low Input Bias Currents: 250 nA, Max
- Four Amplifiers Per Package
- Internally Compensated
- Common Mode Range Extends to Negative Supply
- Industry Standard Pinouts

### QUAD DIFFERENTIAL INPUT OPERATIONAL AMPLIFIERS

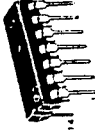
### SILICON MONOLITHIC INTEGRATED CIRCUIT



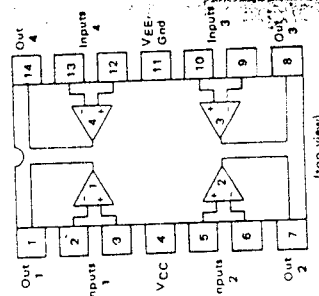
J SUFFIX  
CERAMIC PACKAGE  
CASE 632  
TO-116



N SUFFIX  
PLASTIC PACKAGE  
CASE 640  
(LM224, LM324, LM2902 only)



### PIN CONNECTIONS



ORDERING INFORMATION		
Device	Temperature Range	Package
LM124J	-55 to +125°C	Ceramic DIP
LM2902J	-40 to +85°C	Ceramic DIP
LM2902N	-40 to +85°C	Plastic DIP
LM224J	-25 to +85°C	Ceramic DIP
LM224N	-25 to +85°C	Plastic DIP
LM324J	0 to +70°C	Ceramic DIP
LM324N	0 to +70°C	Plastic DIP

### MAXIMUM RATINGS (TA = +25°C unless otherwise noted)

Rating	LM124	LM224	LM324	LM2902	Unit
Power Supply Voltages*	VCC	32	26	26	Vdc
Split Supplies	VCC-VEE	+16	+13	+13	Vdc
Input Differential Voltage Range (1)	V <sub>IDR</sub>	+32	+26	+26	Vdc
Input Common-Mode Voltage Range (1)	V <sub>ICR</sub>	-0.3 to 32	-0.3 to 26	-0.3 to 26	Vdc
Input Forward Current (3)	I <sub>F</sub>	50	—	—	mA
Input ( $V_I < -0.3$ V)	—	—	—	—	—
Output Short Circuit Duration	t <sub>S</sub>	Continuous	—	—	°C
Junction Temperature	T <sub>J</sub>	175	150	150	°C
Ceramic and Metal Packages	—	—	—	—	—
Plastic Package	—	—	—	—	—
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	-55 to +125	-55 to +125	°C
Ceramic and Metal Packages	—	—	—	—	—
Plastic Package	—	—	—	—	—
Operating Ambient Temperature Range	T <sub>A</sub>	-55 to +125	-25 to +85	0 to +70	°C
LM124	—	—	—	—	—
LM224	—	—	—	—	—
LM324	—	—	—	—	—
LM2902	—	—	—	—	—

(1) Split Power Supplies: less than 32 V for the LM124/224/324 and 26 V for the LM2902.  
 (2) For Supply Voltage: minimum input voltage is equal to the supply voltage.  
 (3) This input current will only assist when the input voltage returns to a voltage greater than -0.3 V.

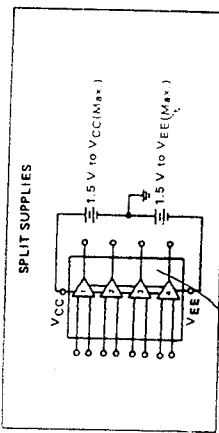
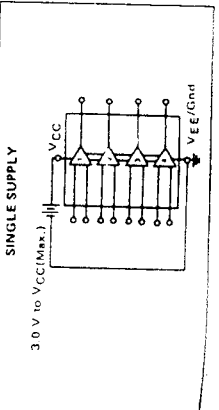
### ELECTRICAL CHARACTERISTICS (V<sub>CC</sub> = 5.0 V, V<sub>EE</sub> = Gnd, T<sub>A</sub> = 25°C unless otherwise noted)

Characteristic	LM124/LM324			LM224			LM2902		
	Min	Typ	Max	Min	Typ	Max	Min	Typ	Max
Input Offset Voltage V <sub>CC</sub> = 5.0 V to 30 V (26 V for LM2902), V <sub>IC</sub> = 0 V to V <sub>CC</sub> - 1.7 V, V <sub>IO</sub> = 1.4 V, R <sub>S</sub> = 0 Ω, T <sub>A</sub> = 25°C T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	2.0	5.0	—	2.0	7.0	—	2.0	7.0
Average Temperature Coefficient of Input Offset Voltage T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	7.0	—	—	7.0	—	—	7.0	—
Input Offset Current	—	3.0	30	—	5.0	50	—	5.0	50
Average Temperature Coefficient of Input Offset Current T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	10	100	—	150	—	—	45	200
Input Bias Current	—	-45	-150	—	-45	-250	—	-45	-250
T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	-50	-300	—	-50	-500	—	-50	-500
Input Common-Mode Voltage Range (Note 2)	V <sub>CC</sub> = 30 V (26 V for LM2902), V <sub>CC</sub> = 30 V (26 V for LM2902), T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub>	0	28.3	0	28.3	0	—	24.3	—
Differential Input Voltage Range	V <sub>IDR</sub>	—	V <sub>CC</sub>	—	V <sub>CC</sub>	—	—	V <sub>CC</sub>	—
Large Signal Open-Loop Voltage Gain	AVOL	50	70	25	100	—	—	100	—
R <sub>L</sub> = 2.0 kΩ, V <sub>CC</sub> = 15 V, For Large V <sub>O</sub> Swing, T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	25	—	15	—	—	—	—	—
Channel Separation	—	-120	—	-120	—	—	-12	—	—
Common-Mode Rejection Ratio	CMRR	70	85	65	70	—	50	70	—
R <sub>S</sub> = 10 kΩ	—	—	—	—	—	—	—	—	—
Power Supply Rejection Ratio	PSRR	65	100	65	100	—	50	100	—
Output Voltage Range	V <sub>OR</sub>	0	3.3	0	3.3	0	—	3.3	—
R <sub>L</sub> = 2 kΩ, I <sub>RL</sub> = 10 kΩ for LM2902, Output Voltage-High Limit (T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> , I <sub>IN</sub> = 11, V <sub>CC</sub> = 30 V (26 V for LM2902), R <sub>L</sub> = 2 kΩ, V <sub>CC</sub> = 30 V (26 V for LM2902), R <sub>L</sub> = 10 kΩ	—	26	—	26	—	—	22	—	—
Output Voltage-Low Limit (Note 1)	—	27	—	27	—	—	23	—	—
V <sub>CC</sub> = 5.0 V, R <sub>L</sub> = 10 kΩ; T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	—	—	—	—	—	—	—	—
Output Source Current (I <sub>OS</sub> ) = +1.0 V, V <sub>CC</sub> = 15 V	I <sub>OS</sub>	—	—	—	—	—	—	—	—
T <sub>A</sub> = 25°C	—	20	—	20	—	—	40	—	—
T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	10	—	10	—	—	20	—	—
Output Sink Current	I <sub>OS</sub>	—	—	—	—	—	—	—	—
V <sub>ID</sub> = 1.0 V, V <sub>CC</sub> = 15 V	—	—	—	—	—	—	—	—	—
T <sub>A</sub> = 25°C	—	10	—	10	—	—	20	—	—
T <sub>A</sub> = T <sub>high</sub> to T <sub>low</sub> (Note 1)	—	5	—	5	—	—	8	—	—
V <sub>ID</sub> = -1.0 V, V <sub>O</sub> = 200 mV, T <sub>A</sub> = 25°C	—	12	—	12	—	—	50	—	—
Output Short Circuit to Ground (Note 3)	I <sub>SC</sub>	—	—	—	—	—	—	—	—
Power Supply Current (I <sub>CC</sub> ) = T <sub>high</sub> to T <sub>low</sub> (Note 1)	I <sub>CC</sub>	—	—	—	—	—	—	—	—
V <sub>CC</sub> = 30 V (26 V for LM2902), V <sub>IO</sub> = 0 V, R <sub>L</sub> = ∞	—	1.5	—	1.5	—	—	3.0	—	—
V <sub>CC</sub> = 5 V, V <sub>IO</sub> = 0 V, R <sub>L</sub> = ∞	—	0.7	—	0.7	—	—	1.2	—	—

NOTES:  
 (1) T<sub>low</sub> = -55°C for LM124, T<sub>high</sub> = +125°C for LM124  
 -40°C for LM2902  
 +85°C for LM2902  
 +25°C for LM224  
 +70°C for LM324  
 +0°C for LM324

0.3 V. The upper end of the common-mode voltage range is V<sub>CC</sub> - 1.7 V, but either or both inputs can go to +32 V without damage (1.25 V for LM2902).

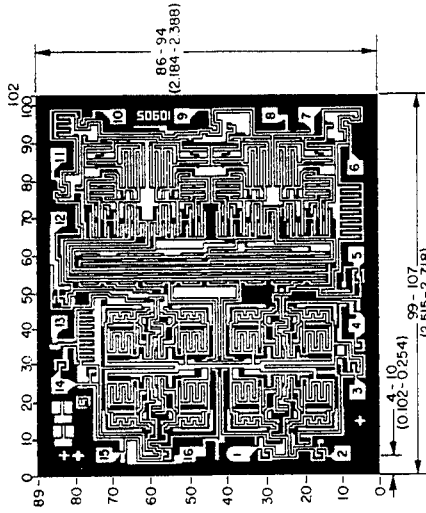
(3) Short circuits from the output to V<sub>CC</sub> can cause excessive heating and eventual destruction. Destructive dissipation can result from simultaneous shorts on all amplifiers.



## D4051B, CD4052B, CD4053B Types

### SPECIAL CONSIDERATIONS

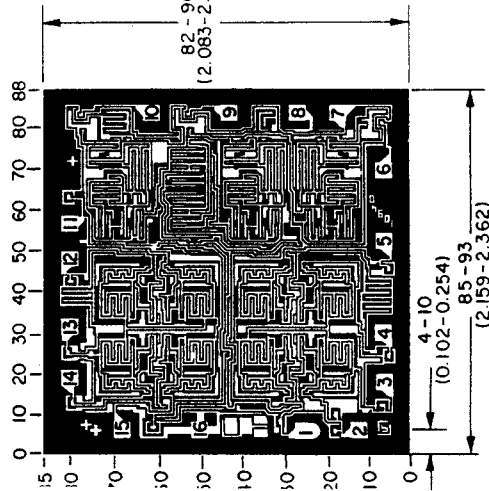
Applications where separate power sources used to drive VDD and the signal inputs, VDD current capability should exceed  $I_{DRL}$  ( $I_{DRL}$  = effective external load). This vision avoids permanent current flow or impaction on the VDD supply when power applied or removed from the CD4051B, 4052B, or CD4053B.



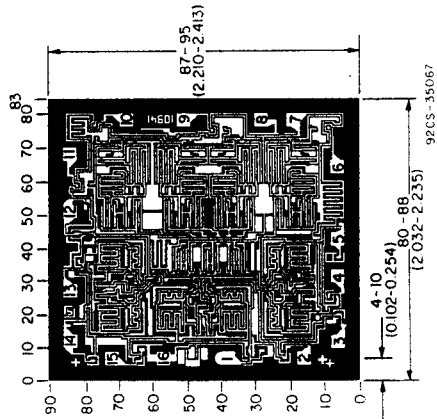
Dimensions and pad layout for CD4051BH.

The photomicrograph and dimensions of each CMOS chip are shown. The chip is separated into individual chips. The angle of cleavage may vary with respect to the chip face for different chips. The actual dimensions of the isolated chip, therefore, may differ slightly from the nominal dimensions shown. The user should consider tolerance dimensions shown.  $\phi$  = mils;  $\mu$  = micrometers; and  $\mu$  = micrometers.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid Graduations are in mils (10<sup>-3</sup> inch).



Dimensions and pad layout for CD4052BH.



Dimensions and pad layout for CD4053BH.

## CMOS Liquid-Crystal Display Drivers

High-Voltage Types (20-Volt Rating)  
 CD4054B — 4-Segment Display Driver  
 CD4055B — BCD to 7-Segment Decoder/Driver with "Display-Frequency" Output  
 CD4056B — BCD to 7-Segment Decoder/Driver with Strobed-Latch Function

The RCA CD4055B and CD4056B types are single-digit, BCD-to-7-segment decoder/driver circuits that provide level-shifting functions on the chip. This feature permits the BCD input-signal swings (VDD to VSS) to be the same as or different from the 7-segment output-signal swings (VDD to VEE). For example, the BCD input-signal swings (VDD to VSS) may be as small as 0 to -3 V, whereas the output-signal drive-signal swing (VDD to VEE) may be as large as 0 to -15V. If VDD to VEE exceeds 15 V, VDD to VSS should be at least 4V (0 to -4V).

The 7-segment outputs are controlled by the DISPLAY-FREQUENCY (DF) input which causes the selected segment outputs to be low, high, or a square-wave output (for liquid-crystal displays). When the DF input is low the output segments will be high when selected by the BCD inputs. When the DF input is high, the output segments will be low when selected by the BCD inputs. When a square-wave is present at the DF input, the selected segments will have a square-wave output that is 180° out of phase with the DF input. Those segments which are not selected will have a square-wave output that is in phase with the input. DF square-wave repetition rates for liquid-crystal displays usually range from 30 Hz (well above flicker rate) to 200 Hz (well below the upper limit of the liquid-crystal frequency response). The CD4055B provides a level-shifted high-amplitude DF output which is required for driving the common electrode in liquid-crystal displays. The CD4056B provides a strobed-latch function at the BCD inputs. Decoding of all input combinations on the CD4055B and CD4056B provides displays of 0 to 9, as well as L, P, H, A, —, and a blank position.

The CD4054B provides level shifting similar to the CD4055B and CD4056B independently strobed latches, and common DF control on 4 signal lines. The CD4054B is intended to provide drive-signal compatibility with the CD4055B and CD4056B 7-segment decoder types for the decimal point, colon, polarity, and similar display lines. A level-shifted high-amplitude DF output can be obtained from any CD4054B output line by connect-

### Features:

- Operation of liquid crystals with CMOS circuits provides ultra-low-power displays
- Equivalent ac output drive for liquid-crystal displays — no external capacitor required
- Voltage doubling across display, e.g. VDD - VEE = 18 V results in effective 36 V p-p drive across selected display segments
- Low- or high-output level dc drive for other types of displays
- On-chip logic-level conversion for different input- and output-level swings
- Full decoding of all input combinations: 0-9, L, H, P, A, —, and blank positions
- Strobed-latch function—CD4054B Series and CD4056B Series
- DISPLAY-FREQUENCY (DF) output for liquid-crystal common-line drive signal—CD4055B Series (CD4054B Series also; see introductory text)
- 100% tested for quiescent current at 20 V over full package temperature range;
- Maximum input current of 1  $\mu$ A at 18 V/100 nA at 18 V and 25°C
- Noise margin (over full package temperature range):
  - 1 V at VDD = 5 V
  - 2 V at VDD = 10 V
  - 2.5 V at VDD = 15 V
- 5-V, 10-V, and 15-V parametric ratings

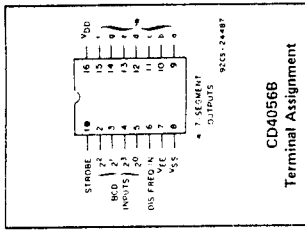
### Applications

- General-purpose displays
- Calculators and meters
- Wall and table clocks
- Industrial control panels
- Portable lab instruments
- Panel meters
- Auto dashboard displays
- Appliance control panels

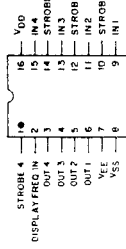
The corresponding input and strobe lines to a low and high level, respectively and applying a square wave to DF in. The CD4054B may also be utilized for logic-level "up conversion" or "down conversion". For example, input-signal swings (VDD to VSS) from +5 to 0 V can be converted to output-signal swings (VDD to VEE) of +5 to -5 V. The level-shifted function on all three types permits the use of different input- and output-signal swings. The input swings from a low level of VSS to a high level of VDD while the output swings from a low level of VEE to the same high level of VDD. Thus, the input and output swings can be selected independently of each other over a 3-to-18 V range. VSS may be connected to VEE when no level-shift function is required.

For the CD4054B and CD4056B, data are

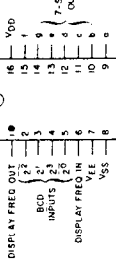
## CD4054B, CD4055B, CD4056B Types



Terminal Assignment



Terminal Assignment



Terminal Assignment

transferred from input to output by placing a high voltage level at the strobe input. A low voltage level at the strobe input latches the data input and the corresponding output segments remain selected (for non-selected) while the strobe is low.

Whenever the level-shifting function is required, the CD4055B can be used by itself to drive a liquid-crystal display (Fig. 16 and Fig. 20). The CD4056B, however, must be used together with a CD4054B to provide the common DF output (Fig. 19). The capability of extending the voltage swing on the negative end (this voltage cannot be extended on the positive end) can be used to advantage in the setup of Fig. 18. Fig. 17 is common to all three types.

The CD4054B-, CD4055B-, and CD4056B-series types are available in 16-lead ceramic dual-in-line packages (D and F suffixes), 16-lead plastic packages (E suffix), 16-lead ceramic flat packages (K suffix), and in chip form (H suffix).

4051B, CD4052B, CD4053B Types

CHARACTERISTICS (Cont'd)

CHARACTERISTIC	TEST CONDITIONS			LIMITS	
	V <sub>ih</sub> (V)	V <sub>DD</sub> (V)	R <sub>L</sub> (kΩ)	TYPICAL VALUE	UNITS
f <sub>f</sub> (-3dB) frequency (Channel ON or Wave Input)	5*	10	1	30	MHz
Harmonic distortion,	V <sub>OS</sub> at Common OUT/IN		CD4053	25	%
	V <sub>OS</sub> at Any Channel		CD4051	20	
	V <sub>OS</sub> at Any Channel		CD4052	60	
HD	2*	5	1	0.3	%
dB through frequency (Channels OFF)	3*	10	10	0.2	
	5*	15	1	0.12	
dB at Crosstalk frequency	V <sub>OS</sub> at Common OUT/IN		CD4053	8	MHz
	V <sub>OS</sub> at Any Channel		CD4051	12	
dB between any 2 channels	Between Any 2 Channels		CD4053	3	MHz
	Between Any 2 Sections		CD4052	6	
dB between any 2 sections	Between Any 2 Sections		CD4053	10	MHz
	Between Any 2 Sections		CD4052	6	
dB between any 2 sections	Between Any 2 Sections		CD4053	2.5	MHz
	Between Any 2 Sections		CD4052	6	
dB between any 2 sections	10	10#	10#	65	mV (Peak)

\* V<sub>DD</sub> = 0, V<sub>SS</sub> = 0, t<sub>r</sub> = 20 ns, V<sub>C</sub> = V<sub>DD</sub> - V<sub>SS</sub> (Square Wave)

# V<sub>DD</sub> = V<sub>SS</sub>

10# k-to-peak voltage symmetrical about V<sub>DD</sub> - V<sub>SS</sub>

TEST CIRCUITS (Cont'd)

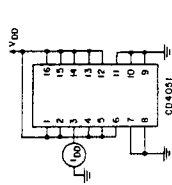


Fig. 20 - Input voltage test circuit (noise immunity).

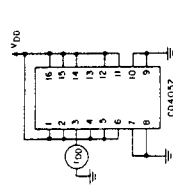


Fig. 22 - Channel ON resistance measurement circuit.

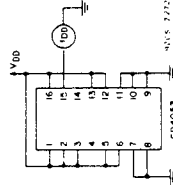


Fig. 17 - OFF channel leakage current - all channels OFF.

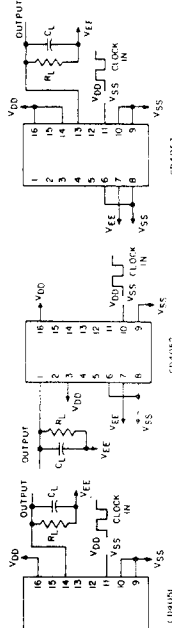


Fig. 18 - Propagation delay address input to signal output.

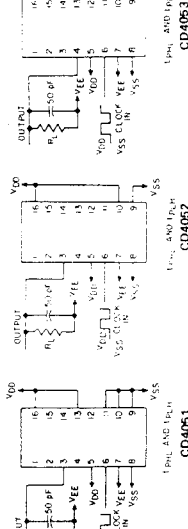


Fig. 19 - Propagation delay inhibit input to signal output.

CD4051B, CD4052B, CD4053B Types

TEST CIRCUITS (Cont'd)

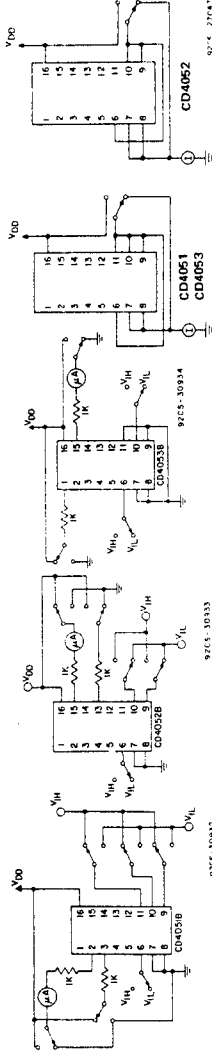


Fig. 21 - Quiescent device current.

Fig. 20 - Input voltage test circuit (noise immunity).

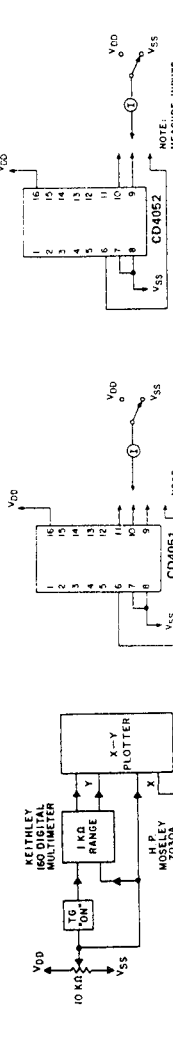


Fig. 23 - Input current.

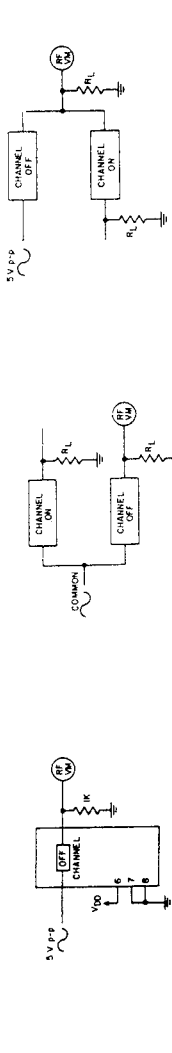


Fig. 25 - Crosstalk between any two channels (all types).

Fig. 24 - Feedthrough (all types).

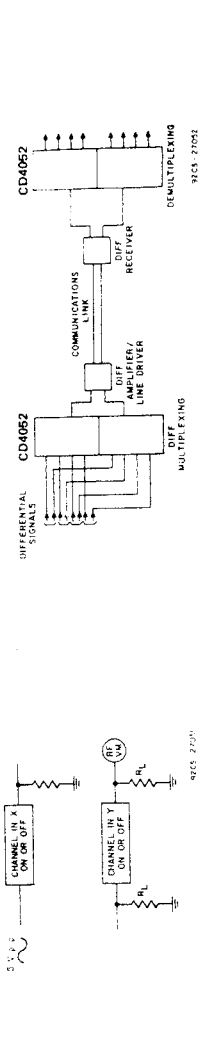


Fig. 27 - Typical time-division application of the CD4052B.

Fig. 26 - Crosstalk between duals or triplets (CD4052B, CD4053B).

# CD4094B Types

## CMOS

### 8-Stage Shift-and-Store Bus Register

High Voltage Types (20 Volt Rating)

The RCA CD4094B is an 8 stage serial shift register having a storage latch associated with each stage for strobing data from the serial input to parallel buffered 3-state outputs. The parallel outputs may be connected directly to common bus lines. Data is shifted on positive clock transitions. The data in each shift register stage is transferred to the storage register when the STROBE input is high. Data in the storage register appears at the outputs whenever the OUTPUT-ENABLE signal is high.

Two serial outputs are available for cascading a number of CD4094B devices. Data is available at the QS serial output terminal on positive clock edges to allow for high-speed operation in cascaded systems in which the clock rise time is fast. The same serial information, available at the QS terminal on the next negative clock edge, provides a means for cascading CD4094B devices when the clock rise time is slow.

The CD4094B types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic package (E suffix), 16-lead ceramic flat package (K suffix), 16-lead ceramic flat package (L suffix), and in clip form (H suffix).

#### Features:

- 3-state parallel outputs for connection to common bus
- Separate serial outputs synchronous to both positive and negative clock edges for cascading
- Medium speed operation - 5 MHz at 10 V (typ.)
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current over full package temperature range
- Maximum input current of 1  $\mu$ A at 18 V over full package temperature range; 100 nA at 18 V and 25°C
- Noise margin (full package temperature range): 1 V at V<sub>DD</sub> = 5 V, 2.5 V at V<sub>DD</sub> = 15 V, 10 V at V<sub>DD</sub> = 20 V
- 5 V, 10 V, and 15 V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13A, "Standard Specifications for Description of 'B' Series CMOS Devices"

#### Applications:

- Serial-to-parallel data conversion
- Remote control holding register
- Dual-rank shift, hold, and bus applications

#### MAXIMUM RATINGS, Absolute-Maximum Values:

- DC SUPPLY VOLTAGE RANGE (V<sub>DD</sub>) ..... -0.5 to +20 V
- INPUT VOLTAGE RANGE (All Inputs) ..... -0.5 to V<sub>DD</sub> +0.5 V
- DC INPUT CURRENT, ANY ONE INPUT .....  $\pm$ 10 nA
- POWER DISSIPATION PER PACKAGE (P<sub>tot</sub>)  
For T<sub>A</sub> = -40 to +85°C (PACKAGE TYPE E) ..... 500 mW
- For T<sub>A</sub> = -55 to +100°C (PACKAGE TYPE F, K) ..... 500 mW
- For T<sub>A</sub> = -55 to +125°C (PACKAGE TYPE D, F, H) ..... 500 mW
- DEVIATE LINEARLY AT 12 mW/°C TO 200 mW
- DEVIATE LINEARLY AT 12 mW/°C TO 200 mW
- OPERATING TEMPERATURE RANGE (All Package Types) ..... -55 to +125°C
- STORAGE TEMPERATURE RANGE (All Package Types) ..... -65 to +150°C
- LEAD TEMPERATURE (DURING SOLDERING) ..... 285°C
- At distance 1/16" ± 1/32" (1.59 ± 0.79 mm) from case for 10 s max.

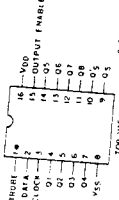
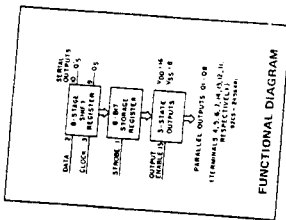


Fig. 1 - Terminal assignment.

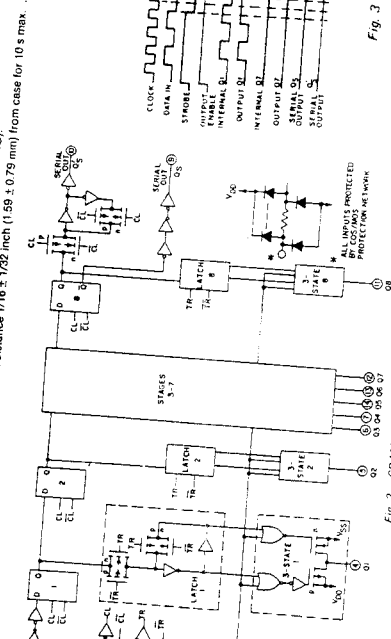


Fig. 3 - Timing diagram.

RECOMMENDED OPERATING CONDITIONS at T<sub>A</sub> = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V <sub>DD</sub> (V)	LIMITS		UNITS
		MIN.	MAX.	
Supply Voltage Range (For TA = Full Package Temperature Range)	5 10 15	3	18	V
Data Setup Time, t <sub>S</sub>	5 10 15	125 55 35	—	ns
Clock Pulse Width, t <sub>W</sub>	5 10 15	200 100 83	—	ns
Clock Input Frequency, f <sub>CL</sub>	5 10 15	dc 2.5 3	1.25	MHz
Clock Input Rise or Fall time, t <sub>r</sub> -t <sub>f</sub> , t <sub>CL</sub> *	5 10 15	—	15 5 5	μs
Strobe Pulse Width, t <sub>W</sub>	5 10 15	200 80 70	—	ns

\*If more than one unit is cascaded (t<sub>CL</sub> for QS only) should be made less than or equal to the sum of the fixed propagation delay at 50 pF and the transition time of the output driving stage for the estimated capacitive load.

# CD4094B Types

TRUTH TABLE

CL*	Output Enable	Strobe	Data	QH†	QL†	Serial Output	QS
0	X	X	X	DC	DC	Q†	Q†
0	X	X	X	DC	DC	Q†	Q†
1	0	X	X	NC	NC	Q†	Q†
1	1	0	0	QH†	QL†	Q†	Q†
1	1	1	1	QH†	QL†	Q†	Q†
1	1	1	1	NC	NC	Q†	Q†

Level Change: X, Level Change; 0, No Change; DC, Open Circuit; NC, No Connection.

\*At the positive clock edge information on the QH, QL register stage is transferred to the QH register stage and the QH output.

†Logic 1 = H; Logic 0 = L; V.

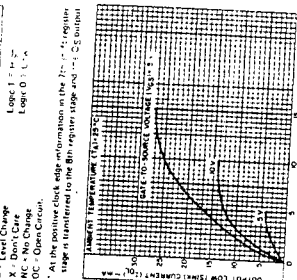


Fig. 4 - Typical output low (sink) current characteristics.

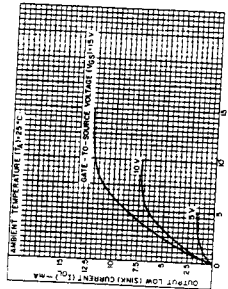


Fig. 5 - Minimum output low (sink) current characteristics.

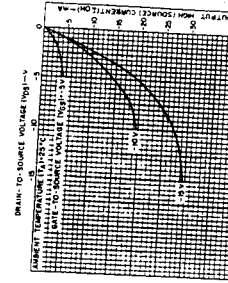


Fig. 6 - Typical output high (source) current characteristics.

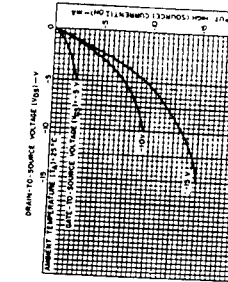


Fig. 7 - Minimum output high (source) current characteristics.

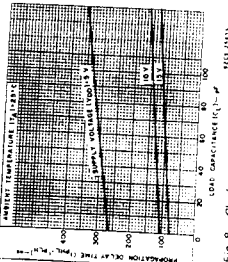


Fig. 8 - Clock to serial output (QS) propagation delay vs. C<sub>L</sub>.

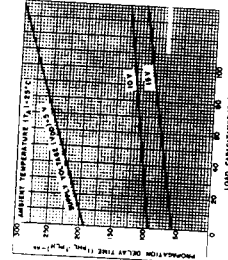


Fig. 9 - Clock to parallel output (QH, QL) propagation delay vs. C<sub>L</sub>.

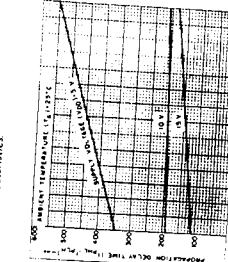


Fig. 10 - Clock to parallel output propagation delay vs. C<sub>L</sub>.

4051B, CD4052B, CD4053B Types

OS Analog Multiplexers/Demultiplexers\*

- Logic-Level Conversion**  
 Voltages Types (20-Volt Rating)
- Applications:
    - Analog and digital multiplexing and demultiplexing
    - A/D and D/A conversion
    - Signal gating

- Features:**
- Wide range of digital and analog signal levels: digital 3 to 20 V, analog to 20 V p-p
  - Low ON resistance: 125 Ω (typ.) over 15 V<sub>p-p</sub> signal-input range for V<sub>DD</sub>-V<sub>EE</sub> = 15 V
  - High OFF resistance: channel leakage of ±100 pA (typ.) @ V<sub>DD</sub>-V<sub>EE</sub> = 18 V
  - Logic-level conversion for digital addressing signals of 3 to 20 V (V<sub>DD</sub>-V<sub>SS</sub> = 3 to 20 V) to switch analog signals to 20 V p-p (V<sub>DD</sub>-V<sub>EE</sub> = 20 V); see introductory text
  - Matched switch characteristics: RON = 5 Ω (typ.) for V<sub>DD</sub>-V<sub>EE</sub> = 15 V
  - Very low quiescent power dissipation under all digital-control input and supply conditions: 0.2 μW (typ.) @ V<sub>DD</sub>-V<sub>SS</sub> = V<sub>DD</sub>-V<sub>EE</sub> = 10 V
  - Binary address decoding on chip
  - 5-, 10-, and 15-V parametric ratings
  - 100% tested for quiescent current at 20 V over full package temperature range; 100 nA at 18 V and 25°C
  - Break-before-make switching eliminates channel overlap

- RECOMMENDED OPERATING CONDITIONS AT T<sub>A</sub> = 25°C (Unless Otherwise Specified)**  
 For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges. Values shown apply to all types except as noted.
- | CHARACTERISTIC   | V <sub>DD</sub> | Min. | Max. | Units |
|--|-----------------|------|------|-------|
| Supply-Voltage Range (T <sub>A</sub> = Full Package-Temp. Range) |                 | 3    | 18   | V     |
| Multiplexer Switch Input Current Capability*                     |                 | —    | 25   | mA    |
| Output Load Resistance   |                 | 100  | —    | Ω     |

\* In certain applications, the external load-resistor current may include both V<sub>DD</sub> and signal-line current when switch is closed. To avoid drawing V<sub>DD</sub> current through the signal-line resistor, the bidirectional switch must not exceed 0.8 volt (calculated from RON values shown in ELECTRICAL CHARACTERISTICS CHART). No V<sub>DD</sub> current will flow through R<sub>L</sub> if the switch current flows into terminal 3 on the CD4051; terminals 3 and 13 on the CD4052; terminals 4, 14, and 15 on the CD4053.

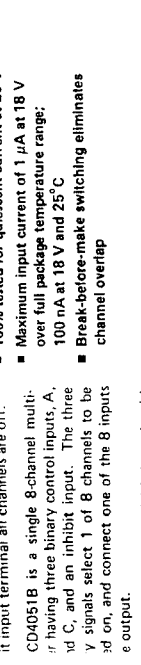


Fig. 3 - Functional diagram of CD4053B.

**MAXIMUM RATINGS, Absolute-Maximum Values:**  
 DC SUPPLY-VOLTAGE RANGE, (V<sub>DD</sub>) (Voltages referred to V<sub>SS</sub> or V<sub>EE</sub>, whichever is more negative)  
 INPUT VOLTAGE RANGE, ALL INPUTS  
 DC INPUT CURRENT, ANY ONE INPUT  
 POWER DISSIPATION PER PACKAGE (P<sub>D</sub>)  
 For T<sub>A</sub> = -40 to +85°C (PACKAGE TYPE E)  
 For T<sub>A</sub> = -55 to +100°C (PACKAGE TYPES D, F, K)  
 For T<sub>A</sub> = +100 to +125°C (PACKAGE TYPES G, J, L)  
 DEVICE DISSIPATION PER OUTPUT TRANSISTOR  
 FOR T<sub>A</sub> = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)  
 OPERATING-TEMPERATURE RANGE (T<sub>A</sub>)  
 PACKAGE TYPE E  
 STORAGE TEMPERATURE RANGE (T<sub>STG</sub>)  
 LEAD TEMPERATURE (DURING SOLDERING)  
 At distance 1/16 ± 1/32 inch (1.59 ± 0.79 mm) from case for 10-s mbs.  
 +265°C

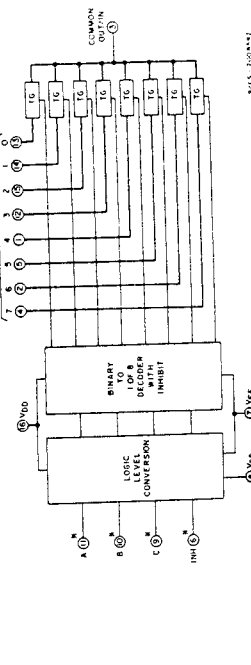


Fig. 1 - Functional diagram of CD4051B.

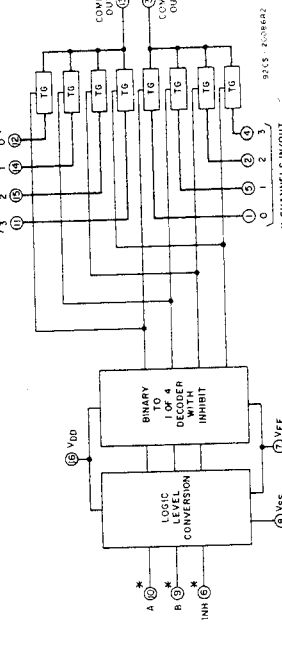


Fig. 2 - Functional diagram of CD4052B.

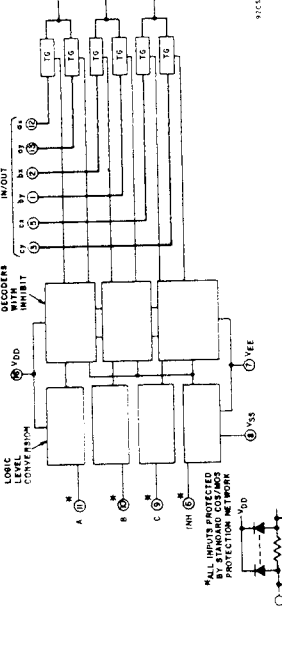


Fig. 3 - Functional diagram of CD4053B.

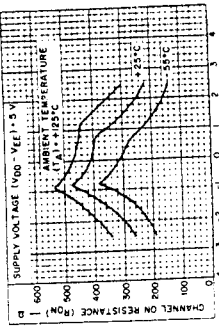


Fig. 4 - Typical channel ON resistance vs. input signal voltage (all types).

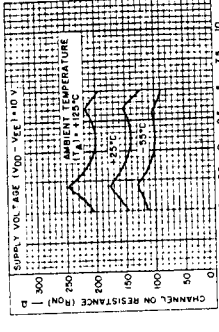


Fig. 5 - Typical channel ON resistance vs. input signal voltage (all types).

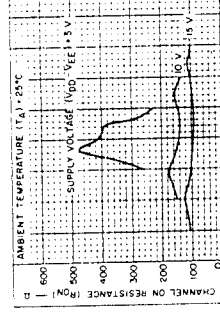


Fig. 6 - Typical channel ON resistance vs. input signal voltage (all types).

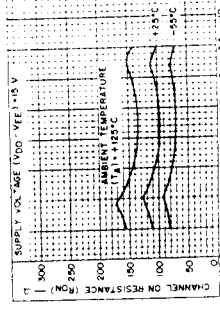


Fig. 7 - Typical channel ON resistance vs. input signal voltage (all types).

On these devices, the pins used as demultiplexers, "CHANNEL IN/OUT", are the pins and the "COMMON OUT/IN" terminals the inputs.

# CD4094B Types

## STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC	CONDITIONS		LIMITS AT INDICATED TEMPERATURES (°C)				UNITS
	V <sub>O</sub> (V)	V <sub>IH</sub> (V)	V <sub>DD</sub> (V)	-55	+25	+125	
Quiescent Device Current, I <sub>DD</sub> Max.	0.5	5	5	150	150	0.04	5
	0.10	10	10	300	300	0.04	10
Output Low (Sink) Current, I <sub>OL</sub> Min.	0.4	0.5	5	0.64	0.42	0.36	0.51
	0.5	0.10	10	1.6	1.5	1.1	0.9
Output High (Source) Current, I <sub>OH</sub> Min.	4.6	0.5	5	-0.64	-0.42	-0.36	-0.51
	2.5	0.5	5	-2	-1.8	-1.3	-1.6
Output Voltage: Low-Level, VOL Max.	9.5	0.10	10	-1.6	-1.5	-1.1	-0.9
	13.5	0.15	15	-4.2	-4	-2.8	-2.4
Output Voltage: High-Level, VOH Min.	0.5	5	5	0.05	0.05	0	0.05
	0.15	15	15	0.05	0.05	0	0.05
Input Low Voltage, V <sub>IL</sub> Max.	0.5	5	5	4.95	4.95	5	5
	1.9	10	10	9.95	9.95	10	10
Input High Voltage, V <sub>IH</sub> Min.	0.5	4.5	5	1.5	1.5	1.5	1.5
	1.5	13.5	15	3	3	3	3
Input Current I <sub>IN</sub> Max.	0.5	4.5	5	3.5	3.5	4	4
	1.9	10	10	7	7	11	11
State Output Leakage Current I <sub>OUT</sub> Max.	0.18	18	18	±0.1	±1	±1	±10
	0.18	18	18	±0.4	±12	±12	±10

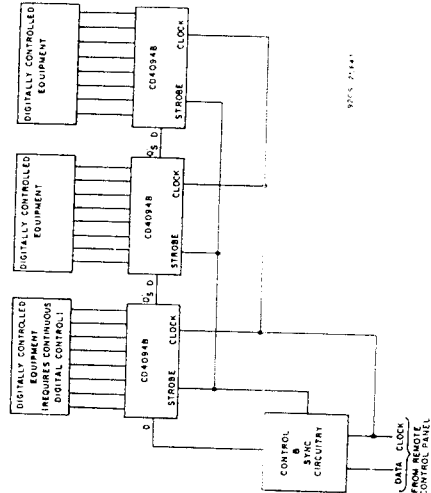


Fig. 14 - Remote control holding register.

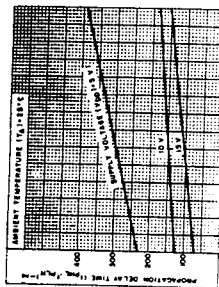


Fig. 11 - Strobe-to-parallel output propagation delay vs. C<sub>L</sub>.

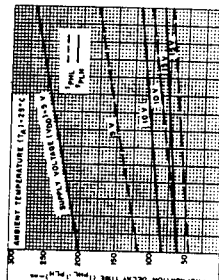


Fig. 12 - Output enable-to-parallel output propagation delay vs. C<sub>L</sub>.

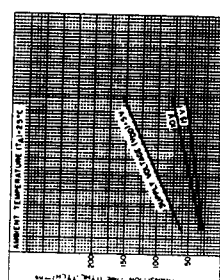


Fig. 13 - Typical transition time vs. load capacitance.

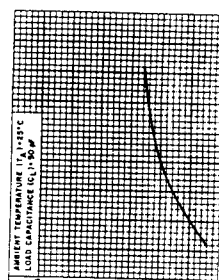


Fig. 15 - Typical maximum-clock-frequency vs. supply voltage.

# CD4094B Types

## DYNAMIC ELECTRICAL CHARACTERISTICS

At T<sub>A</sub>=25°C; Input tr = 20 ns, C<sub>L</sub> = 50 pF, R<sub>L</sub> = 200 kΩ

CHARACTERISTIC	V <sub>DD</sub> (V)	LIMITS			UNITS
		MIN.	TYP.	MAX.	
Propagation Delay Time, t <sub>PHL</sub> , t <sub>PLH</sub> Clock to Serial Output Q <sub>S</sub>	5	—	300	600	ns
	10	—	125	250	
	15	—	95	190	
Clock to Serial Output Q <sub>S</sub>	5	—	230	460	ns
	10	—	110	220	
	15	—	75	150	
Clock to Parallel Output	5	—	420	840	ns
	10	—	195	390	
	15	—	135	270	
Strobe to Parallel Output	5	—	290	580	ns
	10	—	145	290	
	15	—	100	200	
Output Enable to Parallel Output: t <sub>PHZ</sub> , t <sub>PZH</sub>	5	—	140	280	ns
	10	—	60	120	
	15	—	45	90	
t <sub>PLZ</sub> , t <sub>PZL</sub>	5	—	100	200	ns
	10	—	50	100	
	15	—	40	80	
Minimum Strobe Pulse Width, t <sub>W</sub>	5	—	100	200	ns
	10	—	40	80	
	15	—	35	70	
Minimum Clock Pulse Width, t <sub>W</sub>	5	—	100	200	ns
	10	—	50	100	
	15	—	40	83	
Minimum Data Setup Time, t <sub>S</sub>	5	—	80	125	ns
	10	—	30	55	
	15	—	20	35	
Transition Time: t <sub>THL</sub> , t <sub>TLH</sub>	5	—	100	200	ns
	10	—	50	100	
	15	—	40	80	
Maximum Clock Input Rise or Fall Time, t <sub>rCL</sub> , t <sub>fCL</sub>	5	15	—	—	μs
	10	5	—	—	
	15	5	—	—	
Maximum Clock Input Frequency, f <sub>CL</sub>	5	1.25	2.5	—	MHz
	10	2.5	5	—	
	15	3	6	—	
Input Capacitance C <sub>IN</sub> (Any Input)	—	—	5	7.5	pF
	—	—	—	—	

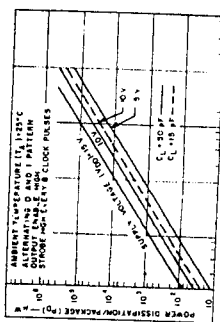


Fig. 16 - Dynamic power dissipation vs. input clock frequency.

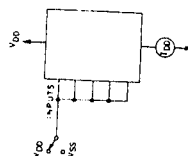


Fig. 17 - Quiescent device current test circuit.

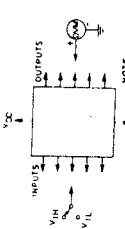


Fig. 18 - Input voltage test circuit.

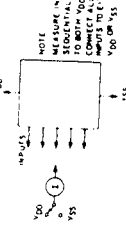
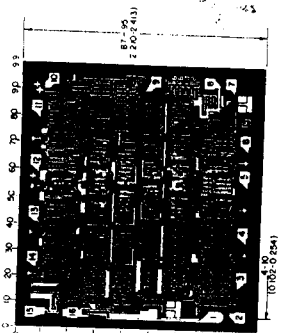


Fig. 19 - Input current test circuit.



The photograph and dimensions of each CD4094B chip represent a chip when it is part of the wafer. When the chip is separated into individual chips, the angle of the chip may vary slightly from the nominal dimensions shown. The user should consider the nominal dimensions shown. The user should consider the nominal dimensions shown.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10<sup>-3</sup> inch).